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PART 2 : RF Exposure Test Report

Applicant Name: SAMSUNG Electronics Co., Ltd. 129, Samsung-ro, Yeongtong-gu, Suwon-Si, Gyeonggi-do, 16677 Rep. of Korea	Date of Issue: Aug. 18, 2020 Test Report No.: HCT-SR-2007-FC006-R1 Test Site: HCT CO., LTD.
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FCC ID:

A3LSMT878U

Equipment Type:	Tablet
Application Type:	Certification
FCC Rule Part(s):	CFR §2.1093
Model name:	SM-T878U
Date of Test:	Jun 22, 2020 ~ Jul. 14. 2020
Results:	Pass

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Tested By

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REVISION HISTORY

The revision history for this test report is shown in table.

Revision No.	Date of Issue	Description
0	Jul. 16, 2020	Initial Release
R1	Aug.18,2020	Revised Sec 9.2.2

This test results were applied only to the test methods required by the standard.

The above Test Report is not related to the accredited test result by (KS Q) ISO/IEC 17025 and KOLAS(Korea Laboratory Accreditation Scheme), which signed the ILAC-MRA.

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1. RF Exposure Limits

1.1 RF Exposure Limits for Frequencies < 6 GHz

HUMAN EXPOSURE	UNCONTROLLED ENVIRONMENT General Population (W/kg) or (mW/g)	CONTROLLED ENVIRONMENT Occupational (W/kg) or (mW/g)
SPATIAL PEAK SAR * (Partial Body)	1.6	8.0
SPATIAL AVERAGE SAR ** (Whole Body)	0.08	0.4
SPATIAL PEAK SAR *** (Hands / Feet / Ankle / Wrist)	4.0	20.0

NOTES:

* The Spatial Peak value of the SAR averaged over any 1 g of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.

** The Spatial Average value of the SAR averaged over the whole-body.

*** The Spatial Peak value of the SAR averaged over any 10 g of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.

Uncontrolled Environments are defined as locations where there is the exposure of individuals who have no knowledge or control of their exposure. The general population/uncontrolled exposure limits are applicable to situations in which the general public may be exposed or in which persons who are exposed as a consequence of their employment may not be mad fully aware of the potential for exposure or cannot exercise control over their exposure. Members of the general public would come under this category when exposure is not employment-related; for example, in the case of a wireless transmitter that exposes persons in its vicinity.

Controlled Environments are defined as locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, (i.e.as a result of employment or occupation). In general, occupational/controlled exposure limits are applicable to situations in which persons are exposed as a consequence of their employment, who have been made fully aware of the potential for exposure and can exercise control over their exposure. This exposure category is also applicable when the exposure is of a transient nature due to incidental passage through a location where the exposure levels may be higher than the general population/uncontrolled limits, but the exposed person is fully aware of the potential for exposure and can exercise control over his or her exposure by leaving the area or by some other appropriate means.

1.2 RF Exposure Limits for Frequencies > 6 GHz

Per §1.1310 (d)(3), the MPE limits are applied for frequencies above 6 GHz. Power Density is expressed in units of W/m² or mW/cm².

Peak Spatially Averaged Power Density was evaluated over a circular area of 4 cm² per interim FCC Guidance for near-field power density evaluations per October 2018 TCB Workshop notes

Frequency range (MHz)	Power density (mW/cm ²)	Averaging time (minutes)
(A) Limits for Occupational/Controlled Exposure		
1,500-100,000	5	6
(B) Limits for General Population/Uncontrolled Exposure		
1,500-100,000	1	30

Note: 1.0 mW/cm² is 10 W/m²

1.3 T Interim Guidance for Time Averaging

Per October 2018 TCB Workshop Notes, the below time-averaging windows can be used for assessing time-averaged exposures for devices that are capable of actively monitoring and adjusting power output over time to comply with exposure limits.

Interim Guidance	Frequency (GHz)	Maximum Averaging Time (sec)
SAR	< 3	100
	3 – 6	60
MPE	6 - 10	30
	10 - 16	14
	16 – 24	8
	24 – 42	4
	42 – 95	2

2. Test Location

2.1 Test Laboratory

Company Name	HCT Co., Ltd.
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Telephone	031-645-6300
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2.2 Test Facilities

Our laboratories are accredited and approved by the following approval agencies according to ISO/IEC 17025.

Korea	National Radio Research Agency (Designation No. KR0032)
	KOLAS (Testing No. KT197)

3. Information of the DUT

3.1 DUT Specification overview

Model Name	SM-T878U	
Equipment Type	Tablet	
FCC ID	A3LSMT878U	
Application Type	Certification	
Applicant	SAMSUNG Electronics Co., Ltd.	
Device Wireless specification overview		
Band & Mode	Operating Mode	Tx Frequency
UMTS 850	Data	826.4 MHz ~ 846.6 MHz
UMTS 1700	Data	1 712.4 MHz ~ 1 752.6 MHz
UMTS 1900	Data	1 852.4 MHz ~ 1 907.6 MHz
LTE Band 2	Data	1 850.7 MHz ~ 1 909.3 MHz
LTE Band 4	Data	1 710.7 MHz ~ 1 754.3 MHz
LTE Band 5 (Cell)	Data	824.7 MHz ~ 848.3 MHz
LTE Band 7	Data	2 502.5 MHz ~ 2 567.5 MHz
LTE Band 12	Data	699.7 MHz ~ 715.3 MHz
LTE Band 13	Data	779.5 MHz ~ 784.5 MHz
LTE Band 14	Data	790.5 MHz ~ 795.5 MHz
LTE Band 25	Data	1 850.7 MHz ~ 1 914.3 MHz
LTE Band 26	Data	814.7 MHz ~ 848.3 MHz
LTE Band 30	Data	2 307.5 MHz ~ 2 312.5 MHz
LTE TDD Band 41	Data	2 498.5 MHz ~ 2 687.5 MHz
LTE Band 66 (AWS)	Data	1 710.7 MHz ~ 1 779.3 MHz
LTE Band 71	Data	665.5 MHz ~ 695.5 MHz
NR Band 2	Data	1 852.5 MHz ~ 1 907.5 MHz
NR Band 5	Data	826.5 MHz ~ 846.5 MHz
NR Band 25	Data	1852.5 MHz ~ 1912.5 MHz
NR Band 41	Data	2 506.02 MHz ~ 2 679.99 MHz
NR Band 66	Data	1 712.5 MHz ~ 1 777.5 MHz
NR Band 71	Data	665.5 MHz - 695.5 MHz
802.11b	Data	2 412 MHz ~ 2 462 MHz
U-NII-1	Data	5 180 MHz ~ 5 240 MHz
U-NII-2A	Data	5 260 MHz ~ 5 320 MHz
U-NII-2C	Data	5 500 MHz ~ 5 720 MHz
U-NII-3	Data	5 745 MHz ~ 5 825 MHz
Bluetooth	Data	2 402 MHz ~ 2 480 MHz

ANT+	Data	2 402 MHz ~ 2 480 MHz
Device Description		
Device Dimension	Overall (Length x Width): 253.75 mm x 165.3 mm Overall Diagonal: 293 mm Display Diagonal: 277 mm	
Device Serial Numbers:	Mode	Serial Number
	WCDMA 2, WCDMA 5, LTE5/12/13/14/26/71 LTE4/25/30/41/66	R32N500KA1X
	NR n2/25/41/66	R32N500KAMT
	mmWave	R32N500KTRE
	The manufacturer has confirmed that the devices tested have the same physical, mechanical and thermal characteristics are within operational tolerances expected for production units.	

Measurement Plot Summery Table

Test Case#	Test Scenario	Tech	Band	DSI	Channel	Frequency	Conducted Plot No.
1	Time-varying Tx. power transmission (Conducted Power, SAR)	LTE	B14	1	23330	793	1
2		UMTS	B5	1	4132	826.4	2
3		sub6 NR	N66	1	344000	1720	3
4	Change in Call	LTE	B14	1	19100	1900	4
5	Tech/Band Switch	LTE	B66	1	132322	1745	5
		UMTS	B4	1	1412	1732.4	
6	SAR1 vs SAR2	LTE	B26	1	26865	831.5	6
		sub6 NR	N66	1	344000	1720	

Test Case#	Transmission Scenario	Test	Technology and Band	mmW Beam	Radiation Plot No.
7	Time-varying Tx power test	Cond. & Rad. Power meas.	LTE Band 2 and n261	Beam ID 152	7
8	Switch in SAR vs. PD	Cond. & Rad. Power meas.	LTE Band 2 and n261	Beam ID 152	8
9	Beam switch test	Cond. & Rad. Power meas.	LTE Band 2 and n261	Beam ID 14 to Beam ID 0	9

Per the Guidance of the FCC and Qualcomm:

For multiple filings with same chipset, the test case reduction proposal for Part 2 testing is:

1. Full set of tests in the first filing, i.e., both **power measurement** and **RF exposure measurement**, are required.
2. For all subsequent filings with the same chipset, only **power measurement** (scenarios (a) – (h)) is required. In the case of scenario (a) time-varying Tx transmission test, only one band (instead of two bands) per technology is sufficient

Part 2 of this model was performed according to the guide above.

3.2 Test Under Dynamic Transmission Condition for RF Exposure Compliance

The equipment under test (EUT) is Samsung Tablet (FCC ID: A3LSMT878U), it contains the Qualcomm SM8250 modem supporting 2G/3G/4G technologies and SDX55 modem supporting mmW 5G NR bands. Both of these modems are enabled with Qualcomm SmartTransmit feature to control and manage transmitting power in real time and to ensure at all times the time-averaged RF exposure is in compliance with the FCC requirement.

This purpose of the Part 2 report is to demonstrate the EUT complies with FCC RF exposure requirement under Tx varying transmission scenarios, thereby validity of Qualcomm Smart Transmit feature for FCC equipment authorization of Samsung Tablet (FCC ID:A3LSMT878U).

The Smart Transmit algorithm maintains the time-averaged transmit power, in turn, time-averaged RF exposure of SAR_design_target for sub 6 radio or PD_design_target for 5G mmW NR, below the predefined time averaged power limit for each characterized technology and band. Smart Transmit allows the device to transmit at higher power instantaneously, as high as P_{max} , when needed, but enforces power limiting to maintain time-averaged transmit power to P_{limit} for frequencies < 6 GHz and *input.power.limit* for frequencies > 6 GHz.

Note that the device uncertainty for sub-6GHz WWAN is 1.0dB for this DUT, the device uncertainty for mmW is 2.1 dB, and the reserve power margin is 3 dB.

This purpose of the Part 2 report is to demonstrate the DUT complies with FCC RF exposure requirement under Tx varying transmission scenarios, thereby validity of Qualcomm[®] Smart Transmit feature implementation in this device. It serves to compliment the Part 0 and Part 1 Test Reports to justify compliance per FCC.

Frequency	Report description	Report Number
Freq. < 6 GHz.	Part 0 SAR Test Report	HCT-SR-2007-FC005
	Part 1 SAR Test Report	HCT-SR-2007-FC007
Freq.> 6 GHz..	Power Density Simulation Report	Power Density Simulation Report Rev.A
	Part 0 Power Density Test Report	HCT-SR-2007-FC002
	Part 1 Power Density Test Report	HCT-SR-2007-FC003
Freq. > 6 GHz.& Freq.< 6 GHz.	RF Exposure Compliance Summary	HCT-SR-2007-FC008

4. Tx Varying Transmission Test Cases and Test Proposal

To validate time averaging feature and demonstrate the compliance in Tx varying transmission conditions, the following transmission scenarios are covered in Part 2 test:

1. During a time-varying Tx power transmission: To prove that the Smart Transmit feature accounts for Tx power variations in time accurately.
2. During a call disconnect and re-establish scenario: To prove that the Smart Transmit feature accounts for history of past Tx power transmissions accurately.
3. During technology/band handover: To prove that the Smart Transmit feature functions correctly during transitions in technology/band.
4. During DSI (Device State Index) change: To prove that the Smart Transmit feature functions correctly during transition from one device state (DSI) to another.
5. During antenna (or beam) switch: To prove that the Smart Transmit feature functions correctly during transitions in antenna (such as AsDiv scenario) or beams (different antenna array configurations).
6. SAR vs. PD exposure switching during sub-6+mmW transmission: To prove that the Smart Transmit feature functions correctly and ensures total RF exposure compliance during transitions in SAR dominant exposure, SAR+PD exposure, and PD dominant exposure scenarios.
7. During time window switch: To prove that the Smart Transmit feature correctly handles the transition from one time window to another specified by FCC, and maintains the normalized time-averaged RF exposure to be less than normalized FCC limit of 1.0 at all times.
8. SAR exposure switching between two active radios (radio1 and radio2): To prove that the Smart Transmit feature functions correctly and ensures total RF exposure compliance when exposure varies among SAR_radio1 only, SAR_radio1 + SAR_radio2, and SAR_radio2 only scenarios.

As described in Part 0 report, the RF exposure is proportional to the Tx power for a SAR- and PD- characterized wireless device. Thus, feature validation in Part 2 can be effectively performed through conducted (for $f < 6\text{GHz}$) and radiated (for $f \geq 6\text{GHz}$) power measurement. Therefore, the compliance demonstration under dynamic transmission conditions and feature validation are done in conducted/radiated power measurement setup for transmission scenario 1 through 8.

To add confidence in the feature validation, the time-averaged SAR and PD measurements are also performed but only performed for transmission scenario 1 to avoid the complexity in SAR and PD measurement (such as, for scenario 3 requiring change in SAR probe calibration file to accommodate different bands and/or tissue simulating liquid).

The strategy for testing in Tx varying transmission condition is outlined as follows:

Demonstrate the total RF exposure averaged over FCC defined time windows does not exceed FCC’s SAR and PD limits, through time-averaged power measurements

Measure conducted Tx power (for $f < 6\text{GHz}$) versus time, and radiated Tx power (EIRP for $f > 10\text{GHz}$) versus time.

Convert it into RF exposure and divide by respective FCC limits to get normalized exposure versus time.

Perform running time-averaging over FCC defined time windows.

Demonstrate that the total normalized time-averaged RF exposure is less than 1 for all transmission scenarios (i.e., transmission scenarios 1, 2, 3, 4, 5, 6, 7, and 8) at all times.

Mathematical expression:

- For sub-6 transmissions only:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_Plimit} * 1g_or_10gSAR_Plimit \quad (1a)$$

$$\frac{\frac{1}{TSAR} \int_{t-TSAR}^t 1g_or_10gSAR(t) dt}{FCC\ SAR\ limit} \leq 1 \quad (1b)$$

- For sub-6 mmW transmission:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_Plimit} * 1g_or_10gSAR_Plimit \quad (2a)$$

$$4cm^2PD(t) = \frac{radiated_Tx_power(t)}{radiated_Tx_power_input_power_limit} * 4cm^2PD_input_power_limit \quad (2b)$$

$$\frac{\frac{1}{TSAR} \int_{t-TSAR}^t 1g_or_10gSAR(t) dt}{FCC\ SAR\ limit} + \frac{\frac{1}{TPD} \int_{t-TPD}^t 4cm^2PD(t) dt}{FCC\ 4cm^2\ PD\ limit} \leq 1 \quad (2c)$$

where, $conducted_Tx_power(t)$, $conducted_Tx_power_Plimit$, and $1g_or_10gSAR_Plimit$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at Plimit, and measured 1gSAR or 10gSAR values at Plimit corresponding to sub-6 transmission. Similarly, $radiated_Tx_power(t)$, $radiated_Tx_power_input_power_limit$, and $4cm^2PD_input_power_limit$ correspond to the measured instantaneous radiated Tx power, radiated Tx power at input.power.limit (i.e., radiated power limit), and 4cm2PD value at input.power.limit corresponding to mmW transmission. Both Plimit and input.power.limit are the parameters pre-defined in Part 0 and loaded via Embedded File System (EFS) onto the EUT. TSAR is the FCC defined time window for sub-6 radio; TPD is the FCC defined time window for mmW radio.

Demonstrate the total RF exposure averaged over FCC defined time windows does not exceed FCC’s SAR and PD limits, through time-averaged SAR and PD measurements. Note as mentioned earlier, this measurement is performed for transmission scenario 1 only.

For sub-6 transmission only, measure instantaneous SAR versus time; for LTE+sub6 NR transmission, request low power (or all-down bits) on LTE so that measured SAR predominantly corresponds to sub6 NR. For LTE + mmW transmission, measure instantaneous E-field versus time for mmW radio and instantaneous conducted power versus time for LTE radio. Convert it into RF exposure and divide by respective FCC limits to obtain normalized exposure versus time. Perform time averaging over FCC defined time window. Demonstrate that the total normalized time-averaged RF exposure is less than 1 for transmission scenario 1 at all times.

Mathematical expression:

- For sub-6 transmission only:

$$1g_or_10gSAR(t) = \frac{\text{conducted_Tx_power}(t)}{\text{conducted_Tx_power_Plimit}} * 1g_or_10gSAR_Plimit \quad (3a)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SARlimit} \leq 1 \quad (3b)$$

- For LTE+mmW transmission:

$$1g_or_10gSAR(t) = \frac{\text{conducted_Tx_power}(t)}{\text{conducted_Tx_power_Plimit}} * 1g_or_10gSAR_Plimit \quad (4a)$$

$$4cm^2PD(t) = \frac{\text{radiated_Tx_power}(t)}{\text{radiated_Tx_power_input_power_limit}} * 4cm^2PD@input_power_limit \quad (4b)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SARlimit} + \frac{\frac{1}{T_{PD}} \int_{t-T_{PD}}^t 4cm^2PD(t) dt}{FCC\ 4cm^2PDlimit} \leq 1 \quad (4c)$$

RF Exposure measurement:

Demonstrate the total RF exposure averaged over predefined time windows does not exceed FCC's SAR and PD limits, through time-averaged SAR and PD measurements for only scenario 1 to add confidence in the Smart Transmit feature validation, while avoiding the complexity in SAR/PD measurement (in particular, for scenario 3 requiring change in SAR probe calibration file to accommodate different bands and/or tissue simulating liquid).

For f < 6 transmission only (Scenario 1): measure instantaneous SAR versus time and demonstrate total time-averaged RF exposure is less than 1.0 at all times.

$$1g_or_10gSAR(t) = \frac{\text{pointSAR}(t)}{\text{pointSAR_Plimit}} * 1g_or_10gSAR_Plimit \quad (5a)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SARlimit} \leq 1 \quad (5b)$$

□ For $f < 6 \text{ GHz} + f \geq 6 \text{ GHz}$ transmission (Scenario 1): measure instantaneous E-field versus time for $f \geq 6$ radio and instantaneous conducted power versus time for $f < 6$ radio, calculate total normalized time-averaged RF exposure versus time using below equations and demonstrate it less than 1.0 at all times.

$$1g_or_10gSAR(t) = \frac{\text{conducted_Tx_power}(t)}{\text{conducted_Tx_power_Plimit}} * 1g_or_10gSAR_Plimit \quad (6a)$$

$$4cm^2PD(t) = \frac{[\text{pointE}(t)]^2}{[\text{pointE_input.power.limit}]^2} * 4cm^2PD_input.power.limit \quad (6b)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC SAR_{limit}} + \frac{\frac{1}{T_{PD}} \int_{t-T_{PD}}^t 4cm^2PD(t) dt}{FCC 4cm^2PD_{limit}} \leq 1 \quad (6c)$$

where, pointSAR(t), PointSAR_Plimit and 1g_or_10gSAR_Plimit correspond to the measured instantaneous point SAR, measured.

Point SAR at Plimit, and measured 1gSAR or 10gSAR values at Plimit corresponding to sub-6 transmission. Similarly, pointE(t), pointE_input.power.limit and 4cm²PD_input.power.limit correspond to the measured instantaneous E-field, E-field at input.power.limit, and 4cm²PD value at input.power.limit corresponding to mmW transmission.

Note: DASY6 measurement system by Schmid & Partner Engineering AG (SPEAG) of Zurich, Switzerland measures relative E-field, and provides ratio of $[\text{pointE}(t)]^2 / [\text{pointE_input.power.limit}]^2$ versus time

Per Qualcomm Document 80-W2112-5 Rev. J,

If OEM has multiple SKUs similar to the design under test (for example, one device with mmW QTM module, second device with mmW module removed), then the sub6 radio Tx chain remains the same. In this case, “normalized quantity” (red square circled in equation (3a), (4a), (5a) and (6a)) determined in Part 2 test from first device can be re-used for the second device. In general, as long as the radio Tx chain under evaluation (including TxAGC uncertainty, layout and components) remains the same as what was initially tested (or granted), the “normalized quantity” determined in Part 2 test can be re-used for those selected test cases if the Plimit remains the same. In this case, the Part 2 testing can be exempt, but new Part 2 report is required to be generated using corresponding measured SAR from new Part 1 report.

5. SAR Time Averaging Validation Test Procedures

This chapter provides the test plan and test procedure for validating Qualcomm Smart Transmit feature for sub-6 transmission. The 100 seconds time window for operating $f < 3\text{GHz}$ is used as an example to detail the test procedures in this chapter. The same test plan and test procedures described in this chapter apply to 60 seconds time window for operating $f \geq 3\text{GHz}$.

5.1 Test sequence determination for validation

Following the FCC recommendation, two test sequences having time-variation in Tx power are predefined for sub-6 ($f < 6\text{GHz}$) validation:

Test sequence 1: request EUT's Tx power to be at maximum power, measured P_{max}^\dagger , for 80s, then requesting for half of the maximum power, i.e., measured $P_{max}/2$, for the rest of the time.

Test sequence 2: request EUT's Tx power to vary with time. This sequence is generated relative to measured P_{max} , measured P_{limit} and calculated $Preserve$ (= measured P_{limit} in dBm - $Reserve_power_margin$ in dB) of EUT based on measured P_{limit} .

The details for generating these two test sequences is described and listed in Appendix A.

NOTE: For test sequence generation, "measured P_{limit} " and "measured P_{max} " are used instead of the " P_{limit} " specified in EFS entry and " P_{max} " specified for the device, because Smart Transmit feature operates against the actual power level of the " P_{limit} " that was calibrated for the EUT. The "measured P_{limit} " accurately reflects what the feature is referencing to, therefore, it should be used during feature validation testing. The RF tune up and device- to-device variation are already considered in Part 0 report prior to determining P_{limit} .

5.2 Test configuration selection criteria for validating Smart Transmit feature

For validating Smart Transmit feature, this section provides a general guidance to select test cases. In practice, an adjustment can be made in test case selection. The justification/clarification may be provided.

5.2.1 Test configuration selection for time-varying Tx power transmission

The Smart Transmit time averaging feature operation is independent of bands, modes, and channels for a given technology. Hence, validation of Smart Transmit in one band/mode/channel per technology is sufficient. Two bands per technology are proposed and selected for this testing to provide high confidence in this validation.

The criteria for the selection are based on the P_{limit} values determined in Part 0 report. Select two bands* in each supported technology that correspond to least** and highest*** P_{limit} values that are less than P_{max} for validating Smart Transmit.

* If one P_{limit} level applies to all the bands within a technology, then only one band needs to be tested. In this case, within the bands having the same P_{limit} , the radio configuration (e.g., # of RBs, channel#) and device position that correspond to the highest measured 1gSAR at P_{limit} shown in Part 1 report is selected.

** In case of multiple bands having the same least P_{limit} within the technology, then select the band having the highest measured 1gSAR at P_{limit} .

*** The band having a higher P_{limit} needs to be properly selected so that the power limiting enforced by Smart Transmit can be validated using the pre-defined test sequences. If the highest P_{limit} in a technology is too high where the power limiting enforcement is not needed when testing with the pre-defined test sequences, then the next highest level is checked. This process is continued within the technology until

the second band for validation testing is determined.

5.2.2 Test configuration selection for change in call

The criteria to select a test configuration for call-drop measurement is:

Select technology/band with least P_{limit} among all supported technologies/bands, and select the radio configuration (e.g., # of RBs, channel#) in this technology/band that corresponds to the highest *measured* 1gSAR at P_{limit} listed in Part 1 report.

In case of multiple bands having same least P_{limit} , then select the band having the highest *measured* 1gSAR at P_{limit} in Part 1 report.

This test is performed with the EUT's Tx power requested to be at maximum power, the above band selection will result in Tx power enforcement (i.e., EUT forced to have Tx power at $P_{reserve}$) for longest duration in one FCC defined time window. The call change (call drop/reestablish) is performed during the Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$). One test is sufficient as the feature operation is independent of technology and band.

5.2.3 Test configuration selection for change in technology/band

The selection criteria for this measurement is, for a given antenna, to have EUT switch from a technology/band with lowest P_{limit} within the technology group (in case of multiple bands having the same P_{limit} , then select the band with highest *measured* 1gSAR at P_{limit}) to a technology/band with highest P_{limit} within the technology group, in case of multiple bands having the same P_{limit} , then select the band with lowest *measured* 1gSAR at P_{limit} in Part 1 report, or vice versa.

This test is performed with the EUT's Tx power requested to be at maximum power, the technology/band switch is performed during Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$).

5.2.4 Test configuration selection for change in antenna

The criteria to select a test configuration for antenna switch measurement is:

Whenever possible and supported by the EUT, first select antenna switch configuration within the same technology/band (i.e., same technology and band combination).

Then, select any technology/band that supports multiple Tx antennas, and has the highest difference in P_{limit} among all supported antennas.

In case of multiple bands having same difference in P_{limit} among supported antennas, then select the band having the highest *measured* 1gSAR at P_{limit} in Part 1 report.

This test is performed with the EUT's Tx power requested to be at maximum power in selected technology/band, and antenna change is conducted during Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$).

5.2.5 Test configuration selection for change in DSI

The criteria to select a test configuration for DSI change test is

Select a technology/band having the $P_{limit} < P_{max}$ within any technology and DSI group, and for the same technology/band having a different P_{limit} in any other DSI group. Note that the selected DSI transition need to be supported by the device.

This test is performed with the EUT's Tx power requested to be at maximum power in selected technology/band,

and DSI change is conducted during Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at *P_{reserve}*).

5.2.6 Test configuration selection for change in time window

FCC specifies different time window for time averaging based on operation frequency. The criteria to select a test configuration for validating Smart Transmit feature and demonstrating the compliance during the change in time window is

Select any technology/band that has operation frequency classified in one time window defined by FCC (such as 100-seconds time window), and its corresponding *P_{limit}* is less than *P_{max}* if possible.

Select the 2nd technology/band that has operation frequency classified in a different time window defined by FCC (such as 60-seconds time window), and its corresponding *P_{limit}* is less than *P_{max}* if possible.

Note it is preferred both *P_{limit}* values of two selected technology/band less than corresponding *P_{max}*, but if not possible, at least one of technologies/bands has its *P_{limit}* less than *P_{max}*.

This test is performed with the EUT's Tx power requested to be at maximum power in selected technology/band. Test for one pair of time windows selected is sufficient as the feature operation is the same.

5.2.7 Test configuration selection for SAR exposure switching

If supported, the test configuration for SAR exposure switching should cover

1. SAR exposure switch when two active radios are in the same time window
2. SAR exposure switch when two active radios are in different time windows. One test with two active radios in any two different time windows is sufficient as Smart Transmit operation is the same for RF exposure switch in any combination of two different time windows. For device supporting LTE + mmW NR, this test is covered in Section 8.2.3 and 8.2.4.

The Smart Transmit time averaging operation is independent of the source of SAR exposure (for example, LTE vs. Sub6 NR) and ensures total time-averaged RF exposure compliance. Hence, validation of Smart Transmit in any one simultaneous SAR transmission scenario (i.e., one combination for LTE + Sub6 NR transmission) is sufficient, where the SAR exposure varies among SARradio1 only, SARradio1 + SARradio2, and SARradio2 only scenarios.

The criteria to select a test configuration for validating Smart Transmit feature during SAR exposure switching scenarios is

- Select any two < 6GHz technologies/bands that the EUT supports simultaneous transmission (for example, LTE+Sub6 NR).
- Among all supported simultaneous transmission configurations, the selection order is select one configuration where both *P_{limit}* of radio1 and radio2 is less than their corresponding *P_{max}*, preferably, with different *P_{limits}*. If this configuration is not available, then, select one configuration that has *P_{limit}* less than its *P_{max}* for at least one radio. If this can not be found, then, select one configuration that has *P_{limit}* of radio1 and radio2 greater than *P_{max}* but with least (*P_{limit}* – *P_{max}*) delta.

Test for one simultaneous transmission scenario is sufficient as the feature operation is the same.

5.3 Test procedures for conducted power measurements

This section provides general conducted power measurement procedures to perform compliance test under dynamic transmission scenarios described in Section 4. In practice, an adjustment can be made in these procedures. The justification/clarification may be provided.

5.3.1 Time-varying Tx power transmission scenario

This test is performed with the two pre-defined test sequences described in Section 5.1 for all the technologies and bands selected in Section 5.2.1. The purpose of the test is to demonstrate the effectiveness of power limiting enforcement and that the time-averaged SAR (corresponding time-averaged Tx power) does not exceed the FCC limit at all times (see Eq. (1a) and (1b)).

Test procedure

1. Measure Pmax, measure Plimit and calculate Preserve (= measured Plimit in dBm – Reserve_power_margin in dB) and follow Section 5.1 to generate the test sequences for all the technologies and bands selected in Section 5.2.1. Both test sequence 1 and test sequence 2 are created based on measured Pmax and measured Plimit of the EUT. Test condition to measure Pmax and Plimit is:

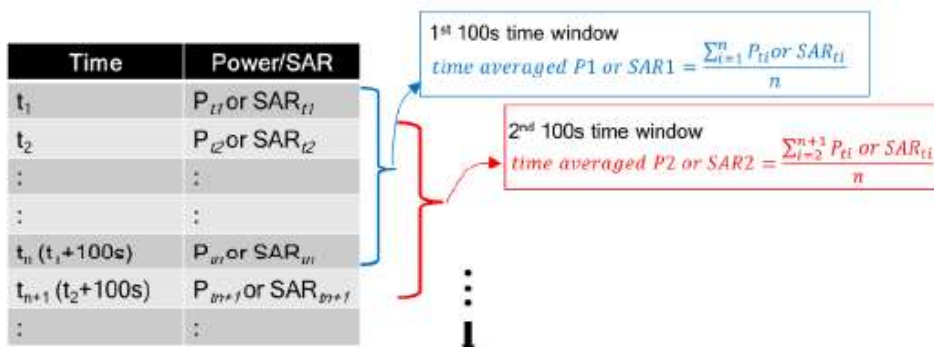
- ▣ Measure Pmax with Smart Transmit disabled and callbox set to request maximum power.
- ▣ Measure Plimit with Smart Transmit enabled and Reserve_power_margin set to 0 dB, callbox set to request maximum power.

2. Set Reserve_power_margin to actual (intended) value (3dB for this EUT based on Part 1 report) and reset power on EUT to enable Smart Transmit, establish radio link in desired radio configuration, with callbox requesting the EUT’s Tx power to be at pre-defined test sequence 1, measure and record Tx power versus time, and then convert the conducted Tx power into 1gSAR or 10gSAR value (see Eq. (1a)) using measured Plimit from above Step 1. Perform running time average to determine time-averaged power and 1gSAR or 10gSAR versus time as illustrated in Figure 5-1 where using 100-seconds time window as an example.

NOTE: In Eq.(1a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at Plimit for the corresponding technology/band/antenna/DSI reported in Part 1 report.

NOTE: For an easier computation of the running time average, 0 dBm can be added at the beginning of the test sequences the length of the responding time window, for example, add 0dBm for 100-seconds so the running time average can be directly performed starting with the first 100-seconds data using excel spreadsheet. This technique applies to all tests performed in this Part 2 report for easier time-averaged computation using excel spreadsheet.

Figure 5-1 100s running average illustration



3. Make one plot containing:

- a. Instantaneous Tx power versus time measured in Step 2,
- b. Requested Tx power used in Step 2 (test sequence 1),
- c. Computed time-averaged power versus time determined in Step 2,
- d. Time-averaged power limit (corresponding to FCC SAR limit of 1.6 W/kg for 1gSAR or 4.0W/kg for 10gSAR) given by

$$\text{Time averaged power limit} = \text{meas. } P_{\text{limit}} + 10 \times \log\left(\frac{\text{FCC SAR limit}}{\text{meas.SAR_Plimit}}\right) \quad (5a)$$

where $\text{meas. } P_{\text{limit}}$ and meas. SAR_Plimit correspond to measured power at P_{limit} and measured SAR at P_{limit} .

4. Make another plot containing:

- a. Computed time-averaged 1gSAR or 10gSAR versus time determined in Step 2
- b. FCC *1gSARlimit* of 1.6W/kg or FCC *10gSARlimit* of 4.0W/kg.

5. Repeat Steps 2 ~ 4 for pre-defined test sequence 2 and replace the requested Tx power (test sequence 1) in Step 2 with test sequence 2.

6. Repeat Steps 2 ~ 5 for all the selected technologies and bands.

The validation criteria are, at all times, the time-averaged power versus time shown in Step 3 plot shall not exceed the time-averaged power limit (defined in Eq. (5a)), in turn, the time-averaged 1gSAR or 10gSAR versus time shown in Step 4 plot shall not exceed the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (1b)).

5.3.2 Change in call scenario

This test is to demonstrate that Smart Transmit feature accurately accounts for the past Tx powers during time-averaging when a new call is established.

The call disconnect and re-establishment needs to be performed during power limit enforcement, i.e., when the EUT's Tx power is at *Preserve* level, to demonstrate the continuity of RF exposure management and limiting in call change scenario. In other words, the RF exposure averaged over any FCC defined time window (including the time windows containing the call change) doesn't exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

Test procedure

1. Measure P_{limit} for the technology/band selected in Section 5.2.2. Measure P_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
2. Set *Reserve_power_margin* to actual (intended) value and reset power on EUT to enable Smart Transmit.
3. Establish radio link with callbox in the selected technology/band.
4. Request EUT's Tx power at 0 dBm for at least one time window specified for the selected technology/band, followed by requesting EUT's Tx power to be at maximum power for about ~60 seconds, and then drop the call for ~10 seconds. Afterwards, re-establish another call in the same radio configuration (i.e., same technology/band/channel) and continue callbox requesting EUT's Tx power to be at maximum power for the remaining time of at least another full duration of the specified time window. Measure and record Tx power versus time. Once the measurement is done, extract instantaneous Tx power versus time, convert the measured conducted Tx power into 1gSAR or 10gSAR value using Eq. (1a), and then perform the running time average to determine time-averaged power and 1gSAR or 10gSAR versus

time.

NOTE: In Eq.(1a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

5. Make one plot containing: (a) instantaneous Tx power versus time, (b) requested power, (c) computed time-averaged power, (d) time-averaged power limit calculated using Eq.(5a).
6. Make another plot containing: (a) computed time-averaged 1gSAR or 10gSAR versus time, and (b) FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

The validation criteria are, at all times, the time-averaged power versus time shall not exceed the time-averaged power limit (defined in Eq.(5a)), in turn, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (1b)).

5.3.3. Change in technology and band

This test is to demonstrate the correct power control by Smart Transmit during technology switches and/or band handovers.

Similar to the change in call test in Section 5.3.2, to validate the continuity of RF exposure limiting during the transition, the technology and band handover needs to be performed when EUT's Tx power is at $P_{reserve}$ level (i.e., during Tx power enforcement) to make sure that the EUT's Tx power from previous $P_{reserve}$ level to the new $P_{reserve}$ level (corresponding to new technology/band). Since the P_{limit} could vary with technology and band, Eq. (1a) can be written as follows to convert the instantaneous Tx power in 1gSAR or 10gSAR exposure for the two given radios, respectively:

$$1g_or_10gSAR_1(t) = \frac{conducted_Tx_power_1(t)}{conducted_Tx_power_P_{limit_1}} * 1g_or_10gSAR_P_{limit_1} \quad (6a)$$

$$1g_or_10gSAR_2(t) = \frac{conducted_Tx_power_2(t)}{conducted_Tx_power_P_{limit_2}} * 1g_or_10gSAR_P_{limit_2} \quad (6b)$$

$$\frac{1}{T_{SAR}} \left[\int_{t-T_{SAR}}^{t_1} \frac{1g_or_10gSAR_1(t)}{FCC\ SAR\ limit} dt + \int_{t-T_{SAR}}^t \frac{1g_or_10gSAR_2(t)}{FCC\ SAR\ limit} dt \right] \leq 1 \quad (6c)$$

where, $conducted_Tx_power_1(t)$, $conducted_Tx_power_P_{limit_1}$, and $1g_or_10gSAR_P_{limit_1}$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit} ,

and measured 1gSAR or 10gSAR value at P_{limit} of technology1/band1; $conducted_Tx_power_2(t)$, $conducted_Tx_power_P_{limit_2}(t)$, and $1g_or_10gSAR_P_{limit_2}$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit} , and measured 1gSAR or 10gSAR value at P_{limit} of technology2/band2. Transition from technology1/band1 to the technology2/band2 happens at time-instant 't1'.

Test procedure

1. Measure P_{limit} for both the technologies and bands selected in Section 5.2.3. Measure P_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
2. Set *Reserve_power_margin* to actual (intended) value and reset power on EUT to enable Smart Transmit
3. Establish radio link with callbox in first technology/band selected.
4. Request EUT's Tx power at 0 dBm for at least one time window specified for the selected technology/band, followed by requesting EUT's Tx power to be at maximum power for about ~60 seconds, and then switch to second technology/band selected. Continue with callbox requesting EUT's Tx power to be at maximum power for the remaining time of at least another full duration of the specified time window. Measure and record Tx power versus time for the full duration of the test.
5. Once the measurement is done, extract instantaneous Tx power versus time, and convert the conducted Tx power into 1gSAR or 10gSAR value using Eq. (6a) and (6b) and corresponding measured P_{limit} values from Step 1 of this section. Perform the running time average to determine time-averaged power and 1gSAR or 10gSAR versus time.

NOTE: In Eq.(6a) & (6b), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

6. Make one plot containing: (a) instantaneous Tx power versus time, (b) requested power, (c) computed time-averaged power, (d) time-averaged power limit calculated using Eq.(5a).
7. Make another plot containing: (a) computed time-averaged 1gSAR or 10gSAR versus time, and (b) FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

The validation criteria are, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (6c)).

5.3.4 Change in antenna

This test is to demonstrate the correct power control by Smart Transmit during antenna switches from one antenna to another. The test procedure is identical to Section 5.3.3, by replacing technology/band switch operation with antenna switch. The validation criteria are, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

5.3.5 Change in DSI

This test is to demonstrate the correct power control by Smart Transmit during DSI switches from one DSI to another. The test procedure is identical to Section 5.3.3, by replacing technology/band switch operation with DSI switch. The validation criteria are, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

5.3.6 Change in time window

This test is to demonstrate the correct power control by Smart Transmit during the change in averaging time window when a specific band handover occurs. FCC specifies time-averaging windows of 100s for Tx frequency < 3GHz, and 60s for Tx frequency between 3GHz and 6GHz.

To validate the continuity of RF exposure limiting during the transition, the band handover test needs to be performed when EUT handovers from operation band less than 3GHz to greater than 3GHz and vice versa. The equations (3a) and (3b) in Section 4 can be written as follows for transmission scenario having change in time window,

$$1gSAR_1(t) = \frac{conducted_Tx_power_1(t)}{conducted_Tx_power_Plimit_1} * 1g_or_10g_SAR_Plimit_1 \quad (7a)$$

$$1gSAR_2(t) = \frac{conducted_Tx_power_2(t)}{conducted_Tx_power_Plimit_2} * 1g_or_10g_SAR_Plimit_2 \quad (7b)$$

$$\frac{1}{T1SAR} \left[\int_{t-T1SAR}^{t_1} \frac{1g_or_10g_SAR_1(t)}{FCC\ SAR\ limit} dt \right] + \frac{1}{T2SAR} \left[\int_{t-T2SAR}^t \frac{1g_or_10g_SAR_2(t)}{FCC\ SAR\ limit} dt \right] \leq 1 \quad (7c)$$

where, *conducted_Tx_power_1(t)*, *conducted_Tx_power_Plimit_1*, and *1g_or_10g_SAR_Plimit_1* correspond to the instantaneous Tx power, conducted Tx power at *Plimit_1*, and compliance *1g_or_10g_SAR* values at *Plimit_1* of band1 with time-averaging window '*T1SAR*'; *conducted_Tx_power_2(t)*, *conducted_Tx_power_Plimit_2*, and *1g_or_10g_SAR_Plimit_2* correspond to the instantaneous Tx power, conducted Tx power at *Plimit_2*, and compliance *1g_or_10g_SAR* values at *Plimit_2* of band2 with time-averaging window '*T2SAR*'. One of the two bands is less than 3GHz, another is greater than 3GHz. Transition from first band with time-averaging window '*T1SAR*' to the second band with time-averaging window '*T2SAR*' happens at time-instant '*t1*'.

Test procedure

1. Measure *P*_{limit} for both the technologies and bands selected in Section 5.2.6. Measure *P*_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
2. Set *Reserve_power_margin* to actual (intended) value and enable Smart Transmit

Transition from 100s time window to 60s time window, and vice versa

3. Establish radio link with callbox in the technology/band having 100s time window selected in Section 5.2.6.
4. Request EUT's Tx power to be at 0 dBm for at least 100 seconds, followed by requesting EUT's Tx power to be at maximum power for about ~140 seconds, and then switch to second technology/band (having 60s time window) selected in Section 5.2.6. Continue with callbox requesting EUT's Tx power to be at maximum power for about ~60s in this second technology/band, and then switch back to the first technology/band. Continue with callbox requesting EUT's Tx power to be at maximum power for at least another 100s. Measure and record Tx power versus time for the entire duration of the test.
5. Once the measurement is done, extract instantaneous Tx power versus time, and convert the conducted Tx power into 1gSAR or 10gSAR value (see Eq. (7a) and (7b)) using corresponding technology/band Step 1 result, and then perform 100s running average to determine time-averaged 1gSAR or 10gSAR versus time. Note that in Eq.(7a) & (7b), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the worst-case 1gSAR or 10gSAR value tested in Part 1 for the selected technologies/bands at *P*_{limit}.
6. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 4.
7. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 5, (b) computed time-averaged 1gSAR versus time determined in Step 5, and (c) corresponding regulatory *1gSAR*_{limit} of 1.6W/kg or *10gSAR*_{limit} of 4.0W/kg.

Transition from 60s time window to 100s time window, and vice versa

8. Establish radio link with callbox in the technology/band having 60s time window selected in Section 5.2.6.
9. Request EUT's Tx power to be at 0 dBm for at least 60 seconds, followed by requesting EUT's Tx power to be at maximum power for about ~80 seconds, and then switch to second technology/band (having 100s time window) selected in Section 5.2.6. Continue with callbox requesting EUT's Tx power to be at maximum power for about ~100s in this second technology/band, and then switch back to the first technology/band. Continue with callbox requesting EUT's Tx power to be at maximum power for the remaining time for a total test time of 500 seconds. Measure and record Tx power versus time for the entire duration of the test.
10. Repeat above Step 5~7 to generate the plots

The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the regulatory *1gSAR*_{limit} of 1.6W/kg or *10gSAR*_{limit} of 4.0W/kg.

5.3.7 SAR exposure switching

This test is to demonstrate that Smart Transmit feature accurately accounts for switching in exposures among SAR from radio1 only, SAR from both radio1 and radio2, and SAR from radio2 only scenarios, and ensures total time-averaged RF exposure complies with the FCC limit. The detailed test procedure for SAR exposure switching in the case of LTE+Sub6 NR non-standalone mode transmission scenario is provided in Appendix B.2.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for radio1 and radio2 in selected band. Test condition to measure conducted P_{limit} is:
 - Establish device in call with the callbox for radio1 technology/band. Measure conducted Tx power corresponding to radio1 P_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
 - Repeat above step to measure conducted Tx power corresponding to radio2 P_{limit} . If radio2 is dependent on radio1 (for example, non-standalone mode of Sub6 NR requiring radio1 LTE as anchor), then establish radio1 + radio2 call with callbox, and request all down bits for radio1 LTE. In this scenario, with callbox requesting maximum power from radio2 Sub6 NR, measured conducted Tx power corresponds to radio2 P_{limit} (as radio1 LTE is at all-down bits)
2. Set *Reserve_power_margin* to actual (intended) value, with EUT setup for radio1 + radio2 call. In this description, it is assumed that radio2 has lower priority than radio1. Establish device in radio1+radio2 call, and request all-down bits or low power on radio1, with callbox requesting EUT's Tx power to be at maximum power in radio2 for at least one time window. After one time window, set callbox to request EUT's Tx power to be at maximum power on radio1, i.e., all-up bits. Continue radio1+radio2 call with both radios at maximum power for at least one time window, and drop (or request all-down bits on) radio2. Continue radio1 at maximum power for at least one time window. Record the conducted Tx power for both radio1 and radio2 for the entire duration of this test.
3. Once the measurement is done, extract instantaneous Tx power versus time for both radio1 and radio2 links. Convert the conducted Tx power for both these radios into 1gSAR or 10gSAR value (see Eq. (6a) and (6b)) using corresponding technology/band P_{limit} measured in Step 1, and then perform the running time average to determine time-averaged 1gSAR or 10gSAR versus time.
4. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 2.
5. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 3, (b) computed time-averaged 1gSAR versus time determined in Step 3, and (c) corresponding regulatory $1gSAR_{limit}$ of 1.6W/kg or $10gSAR_{limit}$ of 4.0W/kg.

The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the regulatory $1gSAR_{limit}$ of 1.6W/kg or $10gSAR_{limit}$ of 4.0W/kg.

5.4 Test procedure for time-varying SAR measurements

This section provides general time-varying SAR measurement procedures to perform compliance test under dynamic transmission scenarios described in Section 4. In practice, an adjustment can be made in these procedures. The justification/clarification may be provided.

To perform the validation through SAR measurement for transmission scenario 1 described in Section 4, the “path loss” between callbox antenna and EUT needs to be calibrated to ensure that the EUT Tx power reacts to the requested power from callbox in a radiated call. It should be noted that when signaling in closed loop mode, protocol-level power control is in play, resulting in EUT not solely following callbox TPC (Tx power control) commands. In other words, EUT response has many dependencies (RSSI, quality of signal, path loss variation, fading, etc.) other than just TPC commands. These dependencies have less impact in conducted setup (as it is a controlled environment and the path loss can be very well calibrated) but have significant impact on radiated testing in an uncontrolled environment, such as SAR test setup. Therefore, the deviation in EUT Tx power from callbox requested power is expected, however the time- averaged SAR should not exceed FCC SAR requirement at all times as Smart Transmit controls Tx power at EUT.

The following steps are for time averaging feature validation through SAR measurement:

1. “Path Loss” calibration: Place the EUT against the phantom in the worst-case position determined based on Section 5.2.1. For each band selected, prior to SAR measurement, perform “path loss” calibration between callbox antenna and EUT. Since the SAR test environment is not controlled and well calibrated for OTA (Over the Air) test, extreme care needs to be taken to avoid the influence from reflections. The test setup is described in Section 7.1.

2. Time averaging feature validation:

i For a given radio configuration (technology/band) selected in Section 5.2.1, enable Smart Transmit and set *Reserve_power_margin* to 0 dB, with callbox to request maximum power, perform area scan, conduct pointSAR measurement at peak location of the area scan. This point SAR value, *pointSAR_Plimit*, corresponds to point SAR at the measured *Plimit* (i.e., measured *Plimit* from the EUT in Step 1 of Section 5.3.1).

ii Set *Reserve_power_margin* to actual (intended) value and reset power on EUT to enable Smart Transmit. Note, if *Reserve_power_margin* cannot be set wirelessly, care must be taken to re-position the EUT in the exact same position relative to the SAM phantom as in above Step 2.i. Establish radio link in desired radio configuration, with callbox requesting the EUT’s Tx power at power levels described by test sequence 1 generated in Step 1 of Section 5.3.1, conduct point SAR measurement versus time at peak location of the area scan determined in Step 2.i of this section. Once the measurement is done, extract instantaneous point SAR vs time data, *pointSAR(t)*, and convert it into instantaneous 1gSAR or 10gSAR vs. time using Eq. (3a), re-written below:

$$1g_or_10gSAR(t) = \frac{pointSAR(t)}{pointSAR_Plimit} * 1g_or_10gSAR_Plimit$$

where, *pointSAR_Plimit* is the value determined in Step 2.i, and *pointSAR(t)* is the instantaneous point SAR measured in Step 2.ii, *1g-or10gSAR_Plimit* is the measured 1g SAR or 10g SAR value listed in Part 1 report.

iii. Perform 100s running average to determine time-averaged 1gSAR or 10gSAR versus time.

iv. Make one plot containing: (a) time-averaged 1gSAR or 10gSAR versus time determined in Step 2.iii of this section, (b) FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

v Repeat 2.ii ~ 2.iv for test sequence 2 generated in Step 1 of Section 5.3.1.

vi. Repeat 2.i ~ 2.v for all the technologies and bands selected in Section 5.2.1.

The time-averaging validation criteria for SAR measurement is that, at all times, the time- averaged 1gSAR or

10gSAR versus time shall not exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (3b)).

6. PD Time Averaging Validation Test Procedures

This chapter provides the test plan and test procedures for validating Qualcomm Smart Transmit feature for mmW transmission. For this EUT, millimeter wave (mmW) transmission is only in non-standalone mode, i.e., it requires an LTE link as anchor.

6.1 Test sequence for validation in mmW NR transmission

In 5G mmW NR transmission, the test sequence for validation is with the callbox requesting EUT's Tx power in 5G mmW NR at maximum power all the time.

6.2 Test configuration selection criteria for validating Smart Transmit feature

6.2.1 Test configuration selection for time-varying Tx power transmission

The Smart Transmit time averaging feature operation is independent of bands, modes, channels, and antenna configurations (beams) for a given technology. Hence, validation of Smart Transmit in any one band/mode/channel per technology is sufficient.

6.2.2 Test configuration selection for change in antenna configuration (beam)

The Smart Transmit time averaging feature operation is independent of bands, modes, channels, and antenna configurations (beams) for a given technology. Hence, validation of Smart Transmit with beam switch between any two beams is sufficient.

6.2.3 Test configuration selection for SAR vs. PD exposure switch during transmission

The Smart Transmit time averaging feature operation is independent of the nature of exposure (SAR vs. PD) and ensures total time-averaged RF exposure compliance. Hence, validation of Smart Transmit in any one band/mode/channel/beam for mmW + sub-6 (LTE) transmission is sufficient, where the exposure varies among SAR dominant scenario, SAR+PD scenario, and PD dominant scenario.

6.3 Test procedures for mmW radiated power measurements

Perform conducted power measurement (for $f < 6\text{GHz}$) and radiated power measurement (for $f > 6\text{GHz}$) for LTE + mmW transmission to validate Smart Transmit time averaging feature in the various transmission scenarios described in Section 4.

This section provides general conducted power measurement procedures to perform compliance test under dynamic transmission scenarios described in Section 4. In practice, an adjustment can be made in these procedures. The justification/clarification may be provided.

6.3.1 Time-varying Tx power scenario

The purpose of the test is to demonstrate the effectiveness of power limiting enforcement and that the time-averaged Tx power when converted into RF exposure values does not exceed the FCC limit at all times (see Eq. (2a), (2b) & (2c) in Section 4).

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE in selected band, and measure radiated Tx power corresponding to input.power.limit in desired mmW band/channel/beam by following below steps:
 - Measure radiated power corresponding to mmW input.power.limit by setting up the EUT's Tx power in desired band/channel/beam at input.power.limit in Factory Test Mode (FTM). This test is performed in a calibrated anechoic chamber. Rotate the EUT to obtain maximum radiated Tx power, keep the EUT in this position and do not disturb the position of the EUT inside the anechoic chamber for the rest of this test.
 - Reset EUT to place in online mode and establish radio link in LTE, measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enabled and $\text{Reserve_power_margin}$ set to 0 dB, callbox set to request maximum power.
2. Set $\text{Reserve_power_margin}$ to actual (intended) value and reset power on EUT to enable Smart Transmit. With EUT setup for a mmW NR call in the desired/selected LTE band and mmW NR band, perform the following steps:
 - Establish LTE and mmW NR connection in desired band/channel/beam used in Step 1. As soon as the mmW connection is established, immediately request all-down bits on LTE link. With callbox requesting EUT's Tx power to be at maximum mmW power to test predominantly PD exposure scenario (as SAR exposure is less when LTE's Tx power is at low power).
 - After 120s, request LTE to go all-up bits for at least 100s. SAR exposure is dominant. There are two scenarios:

If $P_{\text{limit}} < P_{\text{max}}$ for LTE, then the RF exposure margin (provided to mmW NR) gradually runs out (due to high SAR exposure). This results in gradual reduction in the 5G mmW NR transmission power and eventually seized 5G mmW NR transmission when LTE goes to Preserve level.

If $P_{\text{limit}} \geq P_{\text{max}}$ for LTE, then the 5G mmW NR transmission's averaged power should gradually reduce but the mmW NR connection can sustain all the time (assuming TxAGC uncertainty = 0dB).

- Record the conducted Tx power of LTE and radiated Tx power of mmW for the full duration of this test of at least 300s.
3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and mmW links. Convert the conducted Tx power for LTE into 1gSAR or 10gSAR value using Eq. (2a) and P_{limit} measured in Step 1.b, and then divide by FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR to obtain instantaneous normalized 1gSAR or 10gSAR versus time. Perform 100s running average to determine normalized 100s-averaged 1gSAR or 10gSAR versus time.

NOTE: In Eq.(2a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

4. Similarly, convert the radiated Tx power for mmW into $4\text{cm}^2\text{PD}$ value using Eq. (2b) and the radiated Tx power limit (i.e., radiated Tx power at $input.power.limit$) measured in Step 1.a, then divide by FCC $4\text{cm}^2\text{PD}$ limit of $10\text{W}/\text{m}^2$ to obtain instantaneous normalized $4\text{cm}^2\text{PD}$ versus time. Perform 4s running average to determine normalized 4s-averaged $4\text{cm}^2\text{PD}$ versus time.

NOTE: In Eq.(2b), instantaneous radiated Tx power is converted into instantaneous $4\text{cm}^2\text{PD}$ by applying the worst-case $4\text{cm}^2\text{PD}$ value measured at $input.power.limit$ for the selected band/beam in Part 1 report.

5. Make one plot containing: (a) instantaneous conducted Tx power for LTE versus time, (b) computed 100s-averaged conducted Tx power for LTE versus time, (c) instantaneous radiated Tx power for mmW versus time, as measured in Step 2, (d) computed 4s-averaged radiated Tx power for mmW versus time, and (e) time-averaged conducted and radiated power limits for LTE and mmW radio using Eq. (5a) & (5b), respectively:

$$Time\ averaged\ LTE\ power\ limit = meas.P_{limit} + 10 \times \log\left(\frac{FCC\ SAR\ limit}{meas.SAR_{P_{limit}}}\right) \quad (5a)$$

$$Time\ averaged\ mmW\ NR\ power\ limit = meas.EIRP_{input.power.limit} + 10 \times \log\left(\frac{FCC\ PD\ limit}{meas.PD_{input.power.limit}}\right) \quad (5b)$$

where $meas.EIRP_{input.power.limit}$ and $meas.PD_{input.power.limit}$ correspond to measured EIRP at $input.power.limit$ and measured power density at $input.power.limit$.

6. Make another plot containing: (a) computed normalized 100s-averaged 1gSAR or 10gSAR versus time determined in Step 3, (b) computed normalized 4s-averaged $4\text{cm}^2\text{PD}$ versus time determined in Step 4, and (c) corresponding total normalized time-averaged RF exposure (sum of steps (6.a) and (6.b)) versus time.

The validation criteria are, at all times, the total normalized time-averaged RF exposure versus time determined in Step 6.c shall not exceed the normalized limit of 1.0 of FCC requirement (i.e., Eq. (2c)).

6.3.2 Switch in SAR vs. PD exposure during transmission

This test is to demonstrate that Smart Transmit feature is independent of the nature of exposure (SAR vs. PD), accurately accounts for switching in exposures among SAR dominant, SAR+PD, and PD dominant scenarios, and ensures total time-averaged RF exposure compliance.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE in selected band, and measure radiated Tx power corresponding to *input.power.limit* in desired mmW band/channel/beam by following below steps:
 - Measure radiated power corresponding to *input.power.limit* by setting up the EUT's Tx power in desired band/channel/beam at *input.power.limit* in FTM. This test is performed in a calibrated anechoic chamber. Rotate the EUT to obtain maximum radiated Tx power, keep the EUT in this position and do not disturb the position of the EUT inside the anechoic chamber for the rest of this test.
 - Reset EUT to place in online mode and establish radio link in LTE, measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
 2. Set *Reserve_power_margin* to actual (intended) value and reset power in EUT, with EUT setup for LTE + mmW call, perform the following steps:
 - Establish LTE (sub-6) and mmW NR connection with callbox.
 - As soon as the mmW connection is established, immediately request all-down bits on LTE link. Continue LTE (all-down bits) + mmW transmission for more than 100s duration to test predominantly PD exposure scenario (as SAR exposure is negligible from all-down bits in LTE).
 - After 120s, request LTE to go all-up bits, mmW transmission should gradually run out of RF exposure margin if LTE's $P_{limit} < P_{max}$ and seize mmW transmission (SAR only scenario); or mmW transmission should gradually reduce in Tx power and will sustain the connection if LTE's $P_{limit} > P_{max}$.
 - After 75s, request LTE to go all-down bits, mmW transmission should start getting back RF exposure margin and resume transmission again.
 - Record the conducted Tx power of LTE and radiated Tx power of mmW for the entire duration of this test of at least 300s.
 3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and mmW links. Convert the conducted Tx power for LTE into 1gSAR or 10gSAR value using Eq. (2a) and P_{limit} measured in Step 1.b, and then divide by FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR to obtain instantaneous normalized 1gSAR or 10gSAR versus time. Perform 100s running average to determine normalized 100s-averaged 1gSAR or 10gSAR versus time.
- NOTE:** In Eq.(2a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.
4. Similarly, convert the radiated Tx power for mmW into $4\text{cm}^2\text{PD}$ value using Eq. (2b) and the radiated Tx

power limit (i.e., radiated Tx power at *input.power.limit*) measured in Step 1.a, then divide this by FCC 4cm²PD limit of 10W/m² to obtain instantaneous normalized 4cm²PD versus time. Perform 4s running average to determine normalized 4s-averaged 4cm²PD versus time.

NOTE: In Eq.(2b), instantaneous radiated Tx power is converted into instantaneous 4cm²PD by applying the worst-case 4cm²PD value measured at *input.power.limit* for the selected band/beam in Part 1 report.

5. Make one plot containing: (a) instantaneous conducted Tx power for LTE versus time, (b) computed 100s-averaged conducted Tx power for LTE versus time, (c) instantaneous radiated Tx power for mmW versus time, as measured in Step 2, (d) computed 4s-averaged radiated Tx power for mmW versus time, and (e) time-averaged conducted and radiated power limits for LTE and mmW radio using Eq. (5a) & (5b), respectively.

6. Make another plot containing: (a) computed normalized 100s-averaged 1gSAR or 10gSAR versus time determined in Step 3, (b) computed normalized 4s-averaged 4cm²PD versus time determined in Step 4, and (c) corresponding total normalized time-averaged RF exposure (sum of steps (6.a) and (6.b)) versus time.

The validation criteria are, at all times, the total normalized time-averaged RF exposure versus time determined in Step 6.c shall not exceed the normalized limit of 1.0 of FCC requirement (i.e., Eq. (2c)).

6.3.3 Change in antenna configuration (beam)

This test is to demonstrate the correct power control by Smart Transmit during changes in antenna configuration (beam). Since the *input.power.limit* varies with beam, the Eq. (2a), (2b) and (2c) in Section 4 are written as below for transmission scenario having change in beam,

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_Plimit} * 1g_or_10gSAR_Plimit \quad (8a)$$

$$4cm^2PD_1(t) = \frac{radiated_Tx_power_1(t)}{radiated_Tx_power_input.power.limit_1} * 4cm^2PD_input.power.limit_1 \quad (8b)$$

$$4cm^2PD_2(t) = \frac{radiated_Tx_power_2(t)}{radiated_Tx_power_input.power.limit_2} * 4cm^2PD_input.power.limit_2 \quad (8c)$$

$$\frac{\frac{1}{TSAR} \int_{t-TSAR}^t 1g_or_10gSAR(t) dt}{FCC SAR limit} + \frac{\frac{1}{TPD} \left[\int_{t-TPD}^{t_1} 4cm^2PD_1(t) dt + \int_{t_1}^t 4cm^2PD_2(t) dt \right]}{FCC 4cm^2 PD limit} \leq 1 \quad (8d)$$

where, *conducted_Tx_power(t)*, *conducted_Tx_power_Plimit*, and *1g_or_10gSAR_Plimit* correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at Plimit, and measured 1gSAR or 10gSAR values at Plimit corresponding to LTE transmission.

Similarly, *radiated_Tx_power_1(t)*, *radiated_Tx_power_input.power.limit_1*, and *4cm²PD_input.power.limit_1* correspond to the measured instantaneous radiated Tx power, radiated Tx power at *input.power.limit*, and 4cm²PD value at *input.power.limit* of beam 1; *radiated_Tx_power_2(t)*, *radiated_Tx_power_input.power.limit_2*, and *4cm²PD_input.power.limit_2* correspond to the measured instantaneous radiated Tx power, radiated Tx power at *input.power.limit*, and 4cm²PD value at *input.power.limit* of beam 2 corresponding to mmW transmission.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE in selected band, and measure radiated Tx power corresponding to input.power.limit in desired mmW band/channel/beam by following below steps:
 - Measure radiated power corresponding to mmW input.power.limit by setting up the EUT's Tx power in desired band/channel at input.power.limit of beam 1 in FTM. Do not disturb the position of the EUT inside the anechoic chamber for the rest of this test. Repeat this Step 1.a for beam 2.
 - Reset EUT to place in online mode and establish radio link in LTE, measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enabled and Reserve_power_margin set to 0 dB, callbox set to request maximum power.
2. Set Reserve_power_margin to actual (intended) value and reset power in EUT, With EUT setup for LTE + mmW connection, perform the following steps:
 - Establish LTE (sub-6) and mmW NR connection in beam 1. As soon as the mmW connection is established, immediately request all-down bits on LTE link with the callbox requesting EUT's Tx power to be at maximum mmW power.
 - After beam 1 continues transmission for at least 20s, request the EUT to change from beam 1 to beam 2, and continue transmitting with beam 2 for at least 20s.
 - Record the conducted Tx power of LTE and radiated Tx power of mmW for the entire duration of this test.
3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and mmW links. Convert the conducted Tx power for LTE into 1gSAR or 10gSAR value using the similar approach described in Step 3 of Section 4.3.2. Perform 100s running average to determine normalized 100s-averaged 1gSAR versus time.
4. Similarly, convert the radiated Tx power for mmW NR into 4cm²PD value using Eq. (8b), (8c) and the radiated Tx power limits (i.e., radiated Tx power at input.power.limit) measured in Step 1.a for beam 1 and beam 2, respectively, and then divide the resulted PD values by FCC 4cm²PD limit of 10W/m² to obtain instantaneous normalized 4cm²PD versus time for beam 1 and beam 2. Perform 4s running average to determine normalized 4s-averaged 4cm²PD versus time.

NOTE: In Eq.(8b) and (8c), instantaneous radiated Tx power of beam 1 and beam 2 is converted into instantaneous 4cm²PD by applying the worst-case 4cm²PD value measured at the input.power.limit of beam 1 and beam 2 in Part 1 report, respectively.

5. Since the measured radiated powers for beam 1 and beam 2 in Step 1.a were performed at an arbitrary rotation of EUT in anechoic chamber, repeat Step 1.a of this procedure by rotating the EUT to determine maximum radiated power at input.power.limit in FTM mode for both beams separately. Re-scale the measured instantaneous radiated power in Step 2.c by the delta in radiated power measured in Step 5 and the radiated power measured in Step 1.a for plotting purposes in next Step. In other words, this step essentially converts measured instantaneous radiated power during the measurement in Step 2 into maximum instantaneous radiated power for both beams. Perform 4s running average to compute 4s-averaged radiated Tx power. Additionally, use these EIRP values measured at input.power.limit at respective peak locations to determine the EIRP limits (using Eq. (5b)) for both these beams.

6. Make one plot containing: (a) instantaneous conducted Tx power for LTE versus time, (b) computed 100s-averaged conducted Tx power for LTE versus time, (c) instantaneous radiated Tx power for mmW versus time, as obtained in Step 5, (d) computed 4s-averaged radiated Tx power for mmW versus time, as obtained in Step 5, and (e) time-averaged conducted and radiated power limits for LTE and mmW radio, respectively.

7. Make another plot containing: (a) computed normalized 100s-averaged 1gSAR versus time determined in Step 3, (b) computed normalized 4s-averaged 4cm2PD versus time determined in Step 4, and (c) corresponding total normalized time-averaged RF exposure (sum of steps (6.a) and (6.b)) versus time.

The validation criteria are, at all times, the total normalized time-averaged RF exposure versus time determined in Step 6.c shall not exceed the normalized limit of 1.0 of FCC requirement .

6.4 Test procedure for time-varying PD measurements

The following steps are used to perform the validation through PD measurement for transmission scenario 1 described in Section 4:

1. Place the EUT on the cDASY6 platform to perform PD measurement in the worst-case position/surface for the selected mmW band/beam. In PD measurement, the callbox is set to request maximum Tx power from EUT all the time. Hence, “path loss” calibration between callbox antenna and EUT is not needed in this test.

2. Time averaging feature validation:

- Measure conducted Tx power corresponding to P_{limit} for LTE in selected band, and measure point E-field corresponding to input.power.limit in desired mmW band/channel/beam by following the below steps:

Measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enabled and Reserve_power_margin set to 0 dB, with callbox set to request maximum power.

Measure point E-field at peak location of fast area scan corresponding to input.power.limit by setting up the EUT’s Tx power in desired mmW band/channel/beam at input.power.limit in FTM. Do not disturb the position of EUT and mmW cDASY6 probe.

- Set Reserve_power_margin to actual value (i.e., intended value) and reset power on EUT, place EUT in online mode. With EUT setup for LTE (sub-6) + mmW NR call, as soon as the mmW NR connection is established, request all-down bits on LTE link. Continue LTE (all-down bits) + mmW transmission for more than 100s duration to test predominantly PD exposure scenario. After 120s, request LTE to go all-up bits, mmW transmission should gradually reduce. Simultaneously, record the conducted Tx power of LTE transmission using power meter and point E-field (in terms of ratio of

$$\frac{[pointE(t)]^2}{[pointE_input.power.limit]^2}) \text{ of mmW transmission using cDASY6 E-field probe at peak}$$

c. Once the measurement is done, extract instantaneous conducted Tx power versus time for LTE transmission and $\frac{[pointE(t)]^2}{[pointE_input.power.limit]^2}$ ratio versus time from cDASY6 system

for mmW transmission. Convert the conducted Tx power for LTE into 1gSAR or 10gSAR value using Eq. (4a) and P_{limit} measured in Step 2.a.i, and then divide this by FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR to obtain instantaneous normalized 1gSAR or 10gSAR versus time. Perform 100s running average to determine normalized 100s-averaged 1gSAR or 10gSAR versus time

NOTE: In Eq.(4a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band reported in Part 1 report.

3. Similarly, convert the point E-field for mmW transmission into 4cm2PD value using Eq. (4b) and radiated power limit measured in Step 2.a.ii, and then divide this by FCC 4cm2PD limit of 10W/m² to obtain instantaneous normalized 4cm2PD versus time. Perform 4s running average to determine normalized 4s-averaged 4cm2PD versus time.

4. Make one plot containing: (i) computed normalized 100s-averaged 1gSAR or 10gSAR versus time determined in Step 2.c, (ii) computed normalized 4s-averaged 4cm2PD versus time determined in Step 2.d, and (iii) corresponding total normalized time-averaged RF exposure (sum of steps (2.e.i) and (2.e.ii)) versus time.

The validation criteria are, at all times, the total normalized time-averaged RF exposure versus time determined in Step 2.e.iii shall not exceed the normalized limit of 1.0 of FCC requirement (i.e., Eq. (4c)).

7. Test Configurations

7.1 WWAN (sub-6) transmission

The *P_{limit}* values, corresponding to 1.0 W/kg (1gSAR) and 2.5 W/kg (10gSAR) of *SAR_{design_target}*, for technologies and bands supported by EUT are derived in Part 0 report and summarized in Table 7-1. Note all *P_{limit}* power levels entered in Table 7-1 correspond to average power levels after accounting for duty cycle in the case of TDD modulation schemes (for e.g., GSM, LTE TDD & Sub6 NR TDD).

Table 7-1: *P_{limit}* for supported technologies and bands (*P_{limit}* in EFS file)

Device State Index (DSI)	0	1	Maximum Tune up Power	Maximum Tune up Power
Exposure Scenario	Body SAR	Body SAR		
Averaging Volume Spacing	1g SAR 8,17,23 mm	1g SAR 0 mm		
Mode/Band	<i>P_{Limit}</i> (dBm) Calculated		<i>P_{limit}</i> (dBm)	<i>P_{max}</i> (dBm)
UMTS Band 2	24.4	15.3	13.5	23.5
UMTS Band 4	25.5	14.6	13.5	23.5
UMTS Band 5	26.0	19.1	17.5	23.5
LTE Band 7	26.3	14.1	12.0	22.0
LTE Band 12	28.8	18.3	16.0	24.8
LTE Band 13	27.5	18.2	16.0	24.0
LTE Band 14	26.6	18.6	16.0	24.5
LTE Band 25	25.0	15.8	14.0	24.0
LTE Band 26	27.3	19.3	16.0	24.5
LTE Band 30	26.1	14.4	12.5	22.3
LTE Band 41	29.2	18.7	14.0	24.5
LTE Band 66	25.7	14.9	14.0	24.0
LTE Band 71	28.4	19.5	14.0	24.8
5G NR n5	28.3	19.3	16.0	24.0
5G NR n25	26.5	15.0	14.0	24.0
5G NR n41	24.1	16.2	11.0	24.0
5G NR n66	27.5	15.1	14.0	24.0
5G NR n71	30.8	18.9	14.0	24.5

Note:

1. when the Proximity sensor is triggered ,the *P_{limit}* for DSI=1 is set
2. When *P_{max}* < *P_{limit}*, the DUT will operate at a power level up to *P_{max}*.
3. When DSI=1, *P_{limit}*((Tune-up)< *P_{limit}*(cal), the DUT will operate at a power level up to *P_{limit}* as tune-up document
- 4 Maximum Tune up Power,*P_{max}*. Is configured in NV settings in EUT to limit maximum transmitting power

* Maximum tune up target power, *P_{max}*, is configured in NV settings in EUT to limit maximum transmitting power. This power is converted into peak power in NV settings for TDD schemes. The EUT maximum allowed output power is equal to *P_{max}* + 1dB device uncertainty.

Based on selection criteria described in Section 5.2.1, the selected technologies/bands for testing time-varying test sequences are highlighted in yellow in Table 7-1. As per Part 1 report, the *Reserve_power_margin* (dB) for Samsung tablet (FCC ID: A3LSMT878U) is set to 3dB in EFS, and is used in Part 2 test.

The radio configurations used in Part 2 test for selected technologies, bands, DSIs and antennas are listed in Table 7-2. The corresponding worst-case radio configuration 1gSAR or 10gSAR values for selected technology/band/DSI are extracted from Part 1 report and are listed in the last column of Table 7-2.

Based on equations (1a), (2a), (3a) and (4a), it is clear that Part 2 testing outcome is normalized quantity, which implies that it can be applied to any radio configuration within a selected technology/band/DSI. Thus, as long as applying the worst-case SAR obtained from the worst radio configuration in Part 1 testing to calculate time-varying SAR exposure in equations (1a), (2a), (3a) and (4a), the accuracy in compliance demonstration remains the same.

Table 7-2: Radio configurations selected for Part 2 test

Test Case #	Test Scenario	Tech	Band	DSI	Channel	Frequency [MHz]	RB/RB Offset/Bandwidth (MHz)	Mode	SAR Exposure Scenario	Part 1 Worst Case Measured SAR at P _{limit} 1g (W/kg)
1	Time-varying Tx power transmission	LTE	B14	1	23330	793	1 RB /25 offset /10 MHz BW	QPSK	Body SAR/Rear/ 0 mm	0.636
2		UMTS	B5	1	4132	826.4	-	RMC	Body SAR Top/ 0 mm	0.718
3		Sub6 NR	n66	1	344000	1720	1/1/20 MHz BW	DFT-S-OFDM, QPSK	Body SAR/Rear/ 0 mm	0.847
4	Change in Call	LTE	B14	1	19100	1900	50/25/20 MHz BW	QPSK	Body SAR/Rear/ 0 mm	0.636
5	Tech/Band Switch	LTE	B66	1	132322	1 745	50/25/20 MHz BW	QPSK	Body SAR/Top/ 0 mm	0.833
		UMTS	B4	1	1412	1 732.4		RMC	Body SAR/Rear/ 0 mm	0.834
6	SAR1 vs SAR2	LTE	B26	1	26865	831.5	36/39/15 MHz BW	QPSK	Body SAR/Top/ 0 mm	0.486
		sub6 NR	n66	1	344000	1720	1/1/20 MHz BW	DFT-S-OFDM, QPSK	Body SAR 0 mm	0.847

Note that the EUT has a proximity sensor to manage Body SAR exposure at 0 mm, which is represented using DSI = 1. the maximum 1g SAR among all remaining exposure scenarios or the minimum *P_{limit}* among all remaining exposure scenarios is used in Smart Transmit feature for time averaging operation.

Based on the selection criteria described in Section 7.2, the radio configurations for the Tx varying transmission test cases listed in Section 6 are:

1. Technologies and bands for time-varying Tx power transmission: The test case 1~3 listed in Table 7-2 are selected to test with the test sequences defined in Section 7.1 in both time- varying conducted power measurement and time-varying SAR measurement.
2. Technology and band for change in call test: LTE B14 band (test case 4 in Table 7-2) is selected for performing the call drop test in conducted power setup.
3. Technologies and bands for change in technology/band test: Following the guidelines in Section 5.2.3 and 5.2.4, test case 7 in Table 7-2 is selected for handover test from a technology/band/antenna with highest *P_{limit}* within one technology group (LTE B66, DSI=1 Grip mode), to a technology/band in the same DSI with lowest *P_{limit}* within another technology group (WCDMA B4, DSI=1) in conducted power setup.
4. Technologies and bands for change in DSI: Based on selection criteria in Section 5.2.5, for a given technology and band, This DUT has only one DSI =1 , Grip sensor condition. There is no test case in this section.
5. Technologies and bands for change in time-window/antenna: Since the frequencies of all technologies and bands of this DUT are below 3Ghz for WWLAN, the same time-window of 100s is applied. Test case 5 in Table 7-2 is selected for Technologies and bands for change in antenna

6. Technologies and bands for switch in SAR exposure: Based on selection criteria in Section 5.2.7 Scenario 1, test case 6 in Table 7-2 is selected for SAR exposure switching test in one of the supported simultaneous WWAN transmission scenario, i.e., LTE + Sub6 NR active in the same 100s time window, in conducted power setup. Since this device supports LTE+mmW NR, test for Section 5.2.7 Scenario 2 for RF exposure switch is covered in Sections 8.2.3 and 8.2.4 between LTE (100s window) and mmW NR (4s window).

7.2 LTE + mmW NR transmission

Based on the selection criteria described in Section 6.2, the selections for LTE and mmW NR validation test are listed in Table 7-3. The radio configurations used in this test are listed in Table 7-4.

Table 7-3 Selections for LTE + mmW NR validation measurements

Test Case #	Transmission Scenario	Test	Technology and Band	mmW Beam
7	Time-varying Tx power test	Cond. & Rad. Power meas	LTE Band 2 and n261	Beam ID 152
8	Switch in SAR vs. PD	Cond. & Rad. Power meas.	LTE Band 2 and n261	Beam ID 152
9	Beam switch test	Cond. & Rad. Power meas	LTE Band 2 and n261	Beam ID 14 to Beam ID 0

Table 7-4: Test configuration for LTE + mmW NR validation

Tech	Band	Ant.	DSI	Channel	RB/Offset	Freq. (MHz)	Mode	UL Duty Cycle
LTE	B2(25)	Main 1	1	26365	1/99	1882.5	QPSK	100%
mmW NR	N261	K Patch (Module 0)	-	Middle ch	66/0	27923.52	CP-OFDM, QPSK	75.6%*

* mmW NR callbox UL duty cycle should be configured to be greater than 75% for all LTE+mmW NR Part 2 tests.

8. Time-varying Tx power measurement for below 6GHz frequency

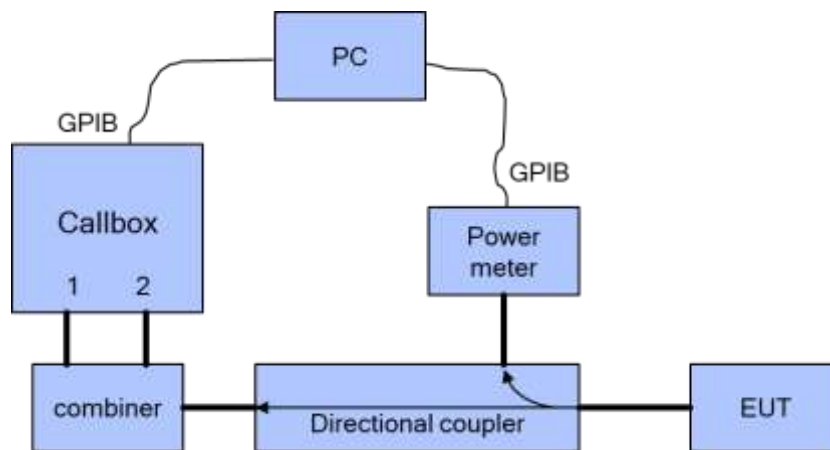
8.1 Conducted Measurement Test setup

Legacy Test Setup

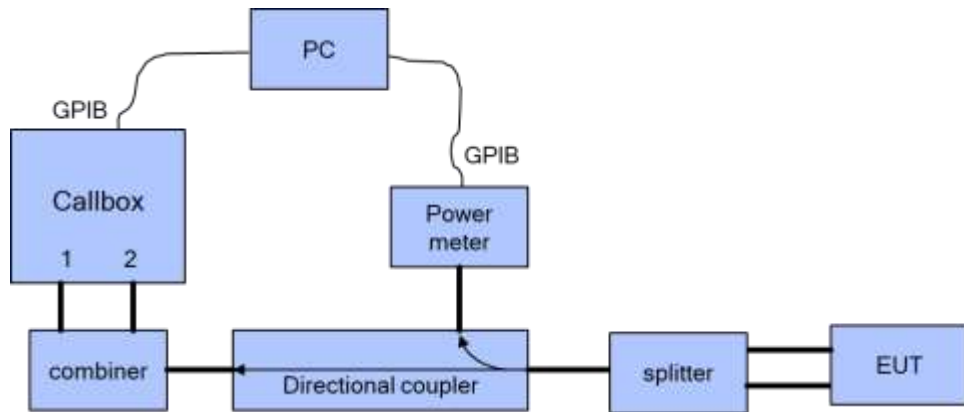
The Rohde & Schwarz CMW500 callbox is used in this test. The test setup picture and schematic are shown in Figures 8-1a for measurements with a single antenna of EUT (see Appendix E –The test Setup Photo 1).and in Figures 8-1b for measurements involving antenna switch (see Appendix E The test Setup Photo 2). For single antenna measurement, one port (RF1 COM) of the callbox is connected to the RF port of the EUT using a directional coupler. For antenna & technology switch measurement, two ports (RF1 COM and RF3 COM) of the callbox used for signaling two different technologies are connected to a combiner, which is in turn connected to a directional coupler. The other end of the directional coupler is connected to a splitter to connect to two RF ports of the EUT corresponding to the two antennas of interest. In both the setups, power meter is used to tap the directional coupler for measuring the conducted output power of the EUT. For time averaging validation test (Section 5.3.1), call drop test (Section 5.3.2), and DSI switch test (Section 5.3.4), only RF1 COM port of the callbox is used to communicate with the EUT. For technology/band switch measurement (Section. 5.3.3), both RF1 COM and RF3 COM port of callbox are used to switch from one technology communicating on RF1 COM port to another technology communicating on RF3 COM port. All the path losses from RF port of EUT to the callbox RF COM port and to the power meter are calibrated and automatically entered as offsets in the callbox and the power meter via test scripts on the PC used to control callbox and power meter.

LTE+Sub6 NR test setup:

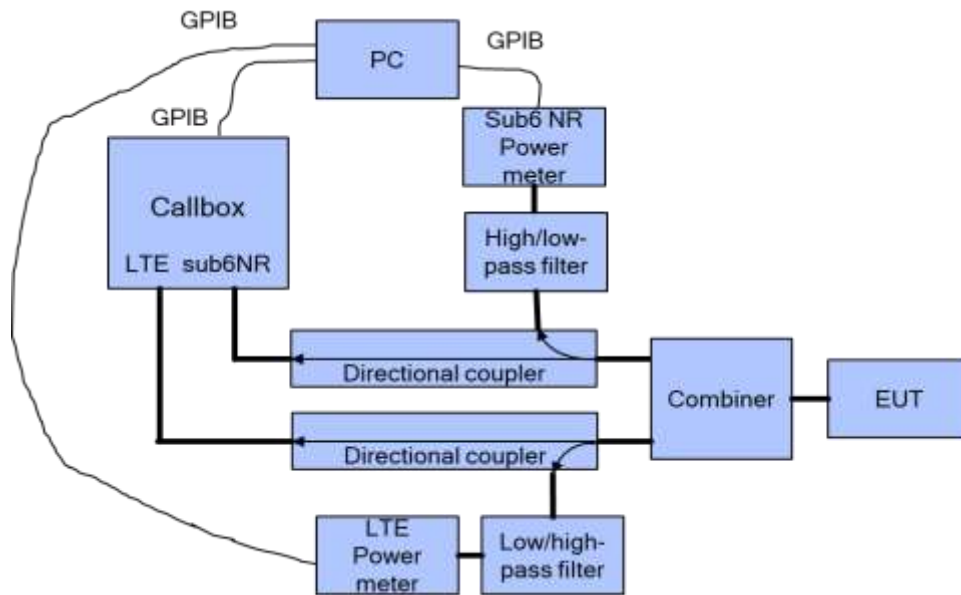
If LTE conducted port and Sub6 NR conducted port are same on this EUT (i.e., they share the same antenna), then low-/high-pass filter is used to separate LTE and Sub6 NR signals for power meter measurement via directional couplers, as shown in below Figures 8-(c) (see Appendix E - Test setup photo-3)



8-1a



8-1b



8-1c

Figure 8-1 Conducted power measurement setup

Both the callbox and power meter are connected to the PC using GPIB cables. Two test scripts are custom made for automation, and the test duration set in the test scripts is 600 seconds.

For time-varying Tx power measurement, the PC runs the 1st test script to send GPIB commands to control the callbox’s requested power versus time, while at the same time to record the conducted power measured at EUT RF port using the power meter. The commands sent to the callbox to request power are:

- 0dBm for 100 seconds
- test sequence 1 or test sequence 2 (defined in Section 5.1 and generated in Section 5.5.1), for 360 seconds
- stay at the last power level of test sequence 1 or test sequence 2 for the remaining time.

Power meter readings are periodically recorded every 100ms. A running average of this measured Tx power over 100 seconds is performed in the post-data processing to determine the 100s-time averaged power. For call drop, technology/band/antenna switch, and DSI switch tests, after the call is established, the callbox is set to request the EUT's Tx power at 0dBm for 100 seconds while simultaneously starting the 2nd test script runs at the same time to start recording the Tx power measured at EUT RF port using the power meter. After the initial 100 seconds since starting the Tx power recording, the callbox is set to request maximum power from the EUT for the rest of the test.

Note that the call drop/re-establish, or technology/band/antenna switch or DSI switch is manually performed when the Tx power of EUT is at *P_{reserve}* level. See Section 5.3 for detailed test procedure of call drop test, technology/band/antenna switch test and DSI switch test.

8.2 P_{limit} and P_{max} measurement Results

The measured *P_{limit}* for all the selected radio configurations given in Table 7-2 are listed in below Table 8-1. *P_{max}* was also measured for radio configurations selected for testing time-varying Tx power transmission scenarios in order to generate test sequences following the test procedures in Section 5.1.

Table 8-1: Measured *P_{limit}* and *P_{max}* of selected radio configuration

Test Case #	Test Scenario	Tech	Band	DSI	Channel	Frequency [MHz]	RB/RB Offset/Bandwidth (MHz)	Mode	SAR Exposure Scenario	P _{limit} EFS Setting[dBm]	Tune Up Target Power P _{max} [dBm]	Measured P _{limit} [dBm]	Measured P _{max} [dBm]	Part 1 Worst Case Measured SAR at P _{limit} 1g (W/kg)
1	Time-varying Tx power transmission	LTE	B14	1	23330	793	1 RB/25 offset /10 MHz BW	QPSK	Body SAR/Rear/0 mm	16	24.5	16.08	24.2	0.636
2		UMTS	B5	1	4132	826.4	-	RMC	Body SAR Top/0 mm	17.5	23.5	17.67	23.71	0.766
3		Sub6 NR	n66	1	344000	1720	1/1/20 MHz BW	DFT-S-OFDM, QPSK	Body SAR/Rear/0mm	14	24	14.12	24.02	0.847
4	Change in Call	LTE	B14	1	19100	1900	50/25/20 MHz BW	QPSK	Body SAR/Rear/0mm	16	24.5	16.08	24.2	0.636
5	Tech/Band Switch	LTE	B66	1	132322	1 745	50/25/20 MHz BW	QPSK	Body SAR/Top/0 mm	14	24	14.14	24.03	0.863
		UMTS	B4	1	1412	1 732.4	-	RMC	Body SAR/Rear/0mm	13.5	23.5	13.82	23.8	0.834
6	SAR1 vs SAR2	LTE	B26	1	26865	831.5	36/39/15 MHz BW	QPSK	Body SAR/Top/0mm	16	24.5	16	24.25	0.486
		sub6 NR	n66	1	344000	1720	1/1/20 MHz BW	DFT-S-OFDM, QPSK	Body SAR/Rear/0mm	14	24	14.12	24.02	0.847

Test Case #	Test Scenario	Tech	Band	DSI	Channel	Frequency [MHz]	RB/RB Offset/Bandwidth (MHz)	Mode	SAR Exposure Scenario
1	Time-varying Tx power transmission	LTE	B2	3	18900	1880	50/24/20 MHz BW	QPSK	Pablet bott
2			B66	3	132072	1720	50/24/20 MHz BW	QPSK	Pablet bott
3		UMTS	B2	3	9400	1880	-	RMC	Pablet bott
4		GPRS	1900	3	661	1880	-	GPRS, 3 Tx	Pablet bott
5		Sub6 NR	n66	3	344000	1720	50/28/20 MHz BW	DFT-S-OFDM, QPSK	Pablet bott
			n2	2	376000	1880	50/28/20 MHz BW	DFT-S-OFDM, QPSK	Hotspot, bo

6	Change in Call	LTE	B2	3	18900	1880	50/24/20 MHz BW	QPSK	Pablet bott
7	Tech/Band Switch	LTE	B2	2	18900	1880	50/24/20 MHz BW	QPSK	Hotspot, bo
		UMTS	B2	2	9400	1880		RMC	Hotspot, bo
8	DSI Switch	LTE	B7	3	21100	2535	50/24/20 MHz BW	QPSK	Phablet, Bo
				2	20850	2510	50/24/20 MHz BW	QPSK	Hotspot, bo
9	Antenna Switch	LTE	B7	2	20850	2510	50/24/20 MHz BW	QPSK	Hotspot, bo
			B2	3	18900	1880	50/24/20 MHz BW	QPSK	Pablet bott
10	SAR1 vs SAR2	LTE	B5	2	20525	836.5	1/25/10 MHz BW	QPSK	Hotspot, ba
		sub6 NR	n2	2	380000	1900	50/28/20 MHz BW	DFT-S-OFDM, QPSK	Hotspot, bo

Note: The device uncertainty of P_{max} is +1dB/-1.5dB as provided by manufacturer.

8.3 Time-varying Tx power measurement results

The measurement setup is shown in Figures 8-1(a), 8-1(b) and 8-1(c). The purpose of the time-varying Tx power measurement is to demonstrate the effectiveness of power limiting enforcement and that the time-averaged Tx power when represented in time-averaged 1gSAR or 10gSAR values does not exceed FCC limit as shown in Eq. (1a) and (1b), rewritten below:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit} \quad (1a)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SAR\ limit} \leq 1 \quad (1b)$$

where, *conducted_Tx_Power(t)*, *conducted_Tx_Plimit*, and *1g_or_10g SAR_Plimit* correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at *Plimit*, and measured 1gSAR and 10gSAR values at *Plimit* reported in Part 1 test (listed in Table 7-2 of this report as well).

Following the test procedure in Section 5.3, the conducted Tx power measurement for all selected configurations are reported in this section. In all the conducted Tx power plots, the dotted line represents the requested power by callbox (test sequence 1 or test sequence 2), the blue curve represents the instantaneous conducted Tx power measured using power meter, the green curve represents time-averaged power and red line represents the conducted power limit that corresponds to FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

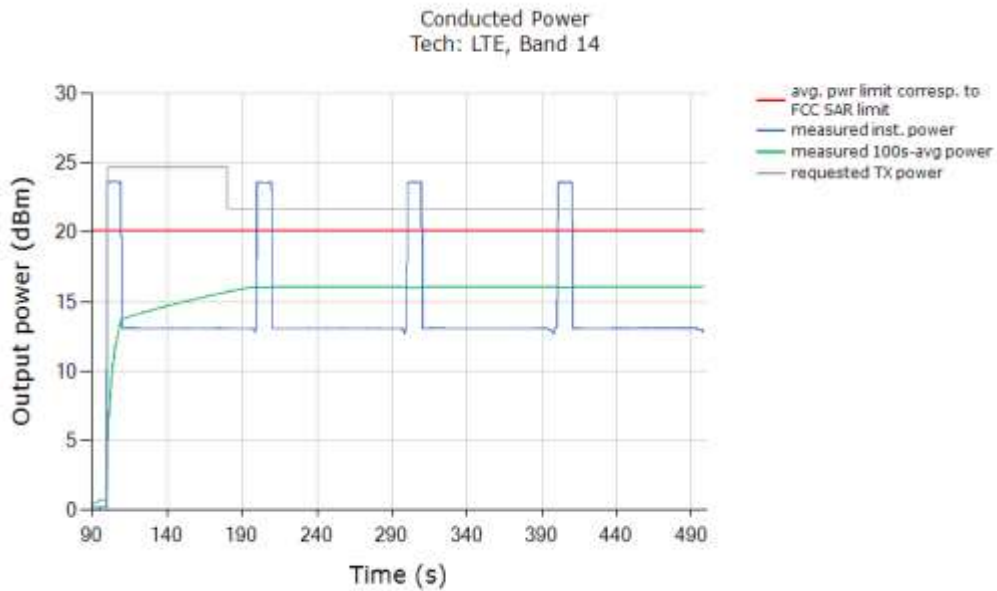
Similarly, in all the 1g or 10gSAR plots (when converted using Eq. (1a)), the green curve represents the 100s time averaged 1gSAR or 10gSAR value calculated based on instantaneous 1gSAR or 10gSAR; and the red line limit represents the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

Time-varying Tx power measurements were conducted on test cases #1 ~ #5 in Table 7-2, by generating test sequence 1 and test sequence 2 given in Appendix A using measured *Plimit* and measured *Pmax* for each of these test cases. Measurement results for test cases #1 ~ #5 are given in Sections 8.3.1 - 8.3.5.

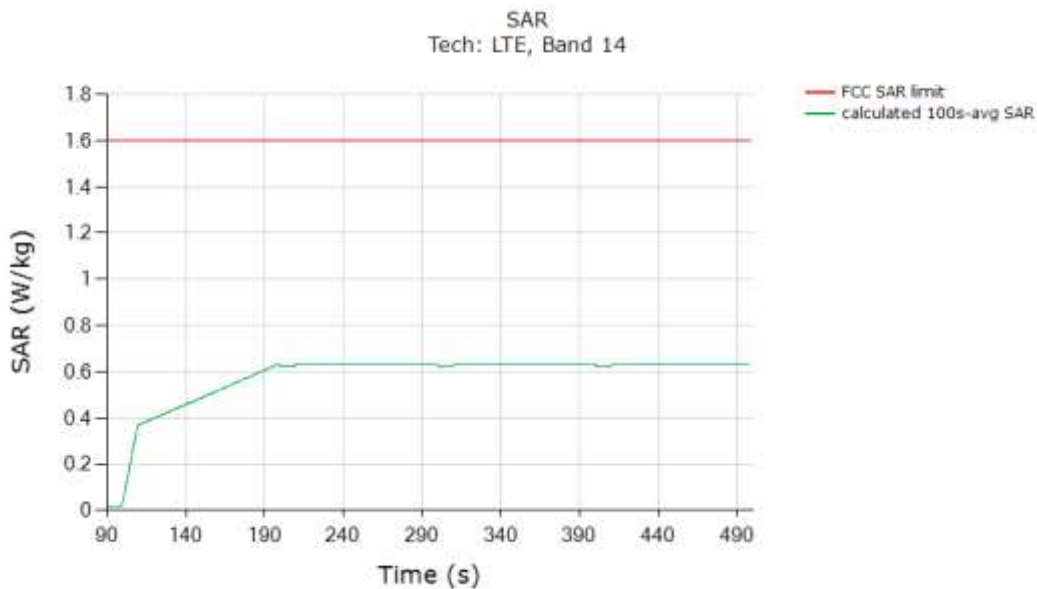
8.3.1 LTE Band 14 (test case 2 in Table 7-2)

Conducted Plot No. 1

Test result for test sequence 1:

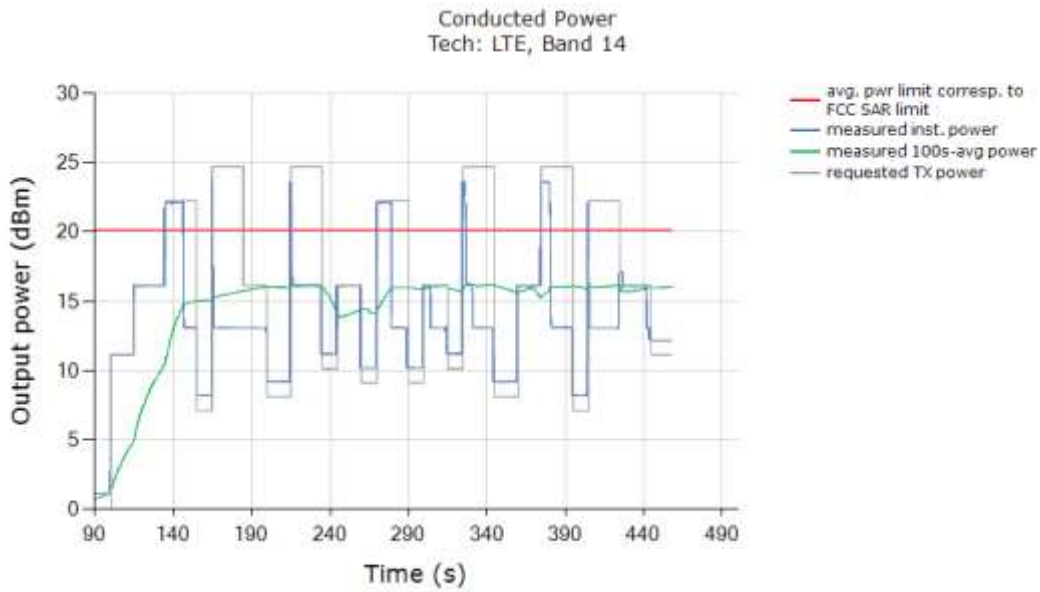


Above time-averaged conducted Tx power is converted/calculated into time-averaged 1g SAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1g SAR versus time does not exceed the FCC limit of 1.6kg for 1g SAR:

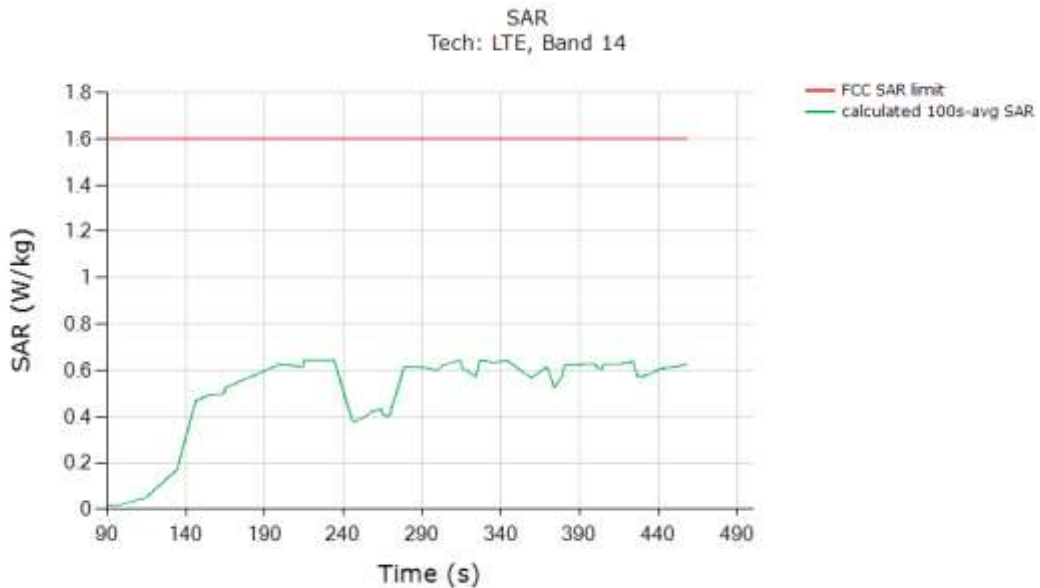


FCC 1g SAR Limit [W/kg]	1.6kg
Max 100s-time averaged 1gSAR (green curve)	0.634 W/kg
Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of measured SAR at <i>P</i> _{limit} (last column in Table 7-2).	

Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6kg for 1gSAR:

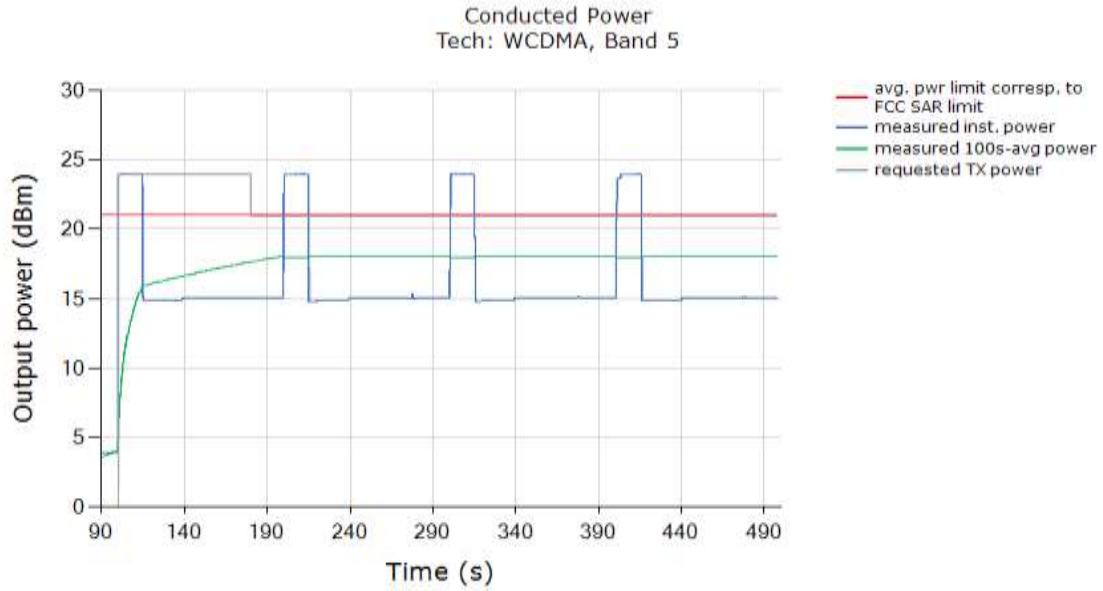


FCC 1g SAR Limit [W/kg]	1.6 W/kg
Max 100s-time averaged 1gSAR (green curve)	0.642 W/kg
Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of measured SAR at <i>P</i> limit (last column in Table 7-2).	

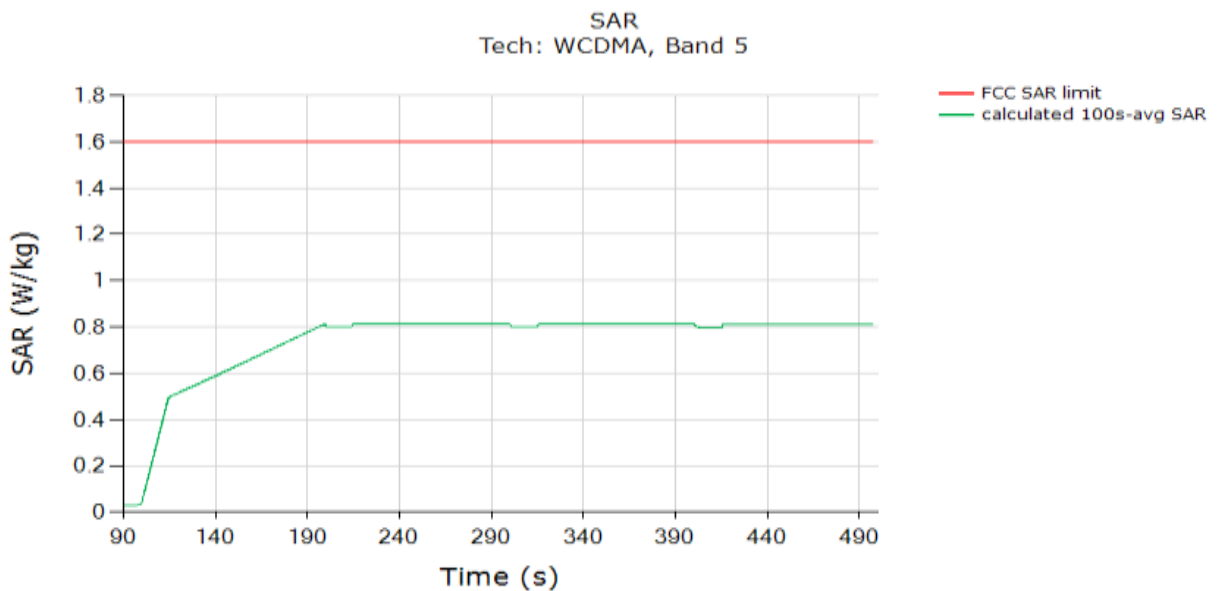
8.3.2 UMTS B5 (test case 2 in Table 7-2)

Conducted Plot No. 2

Test result for test sequence 1:



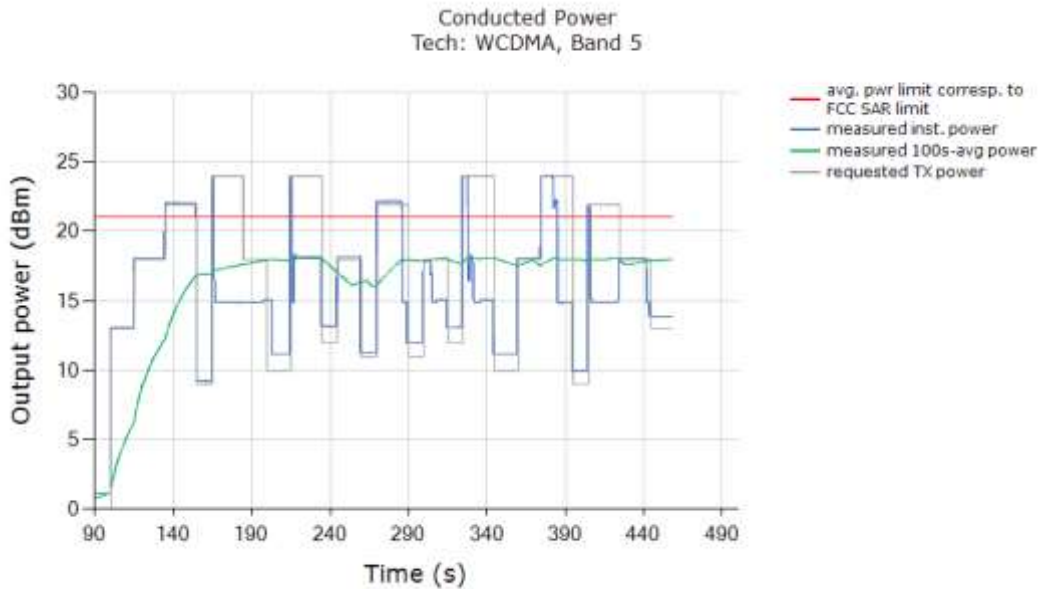
Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6kg for 1gSAR:



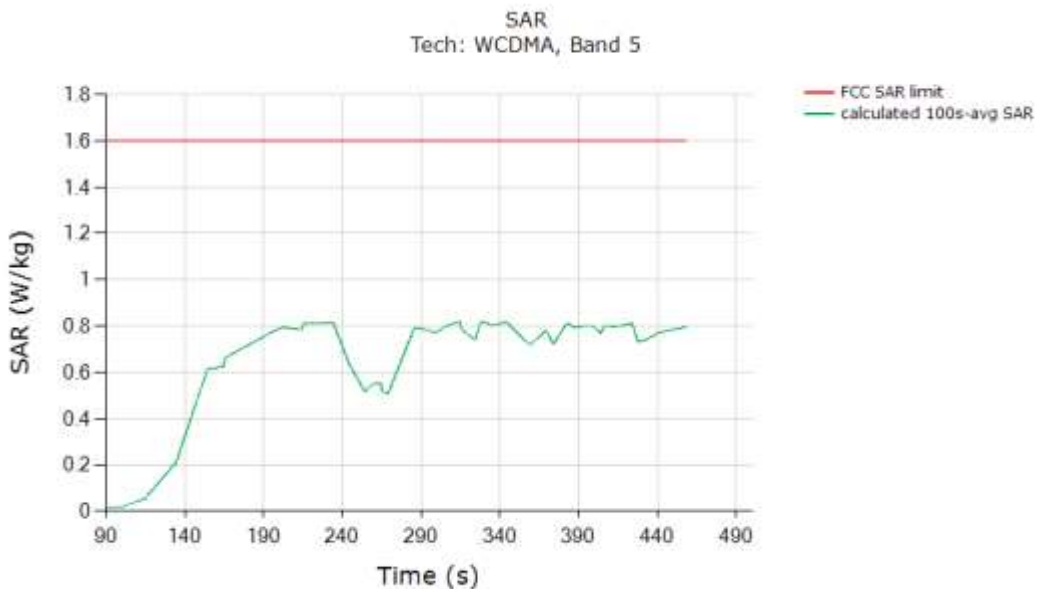
FCC 1g SAR Limit [W/kg]	1.6kg
Max 100s-time averaged 1gSAR (green curve)	0.813 W/kg

Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of measured SAR at *Plimit* (last column in Table 7-2).

Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6W/kg for 1gSAR:

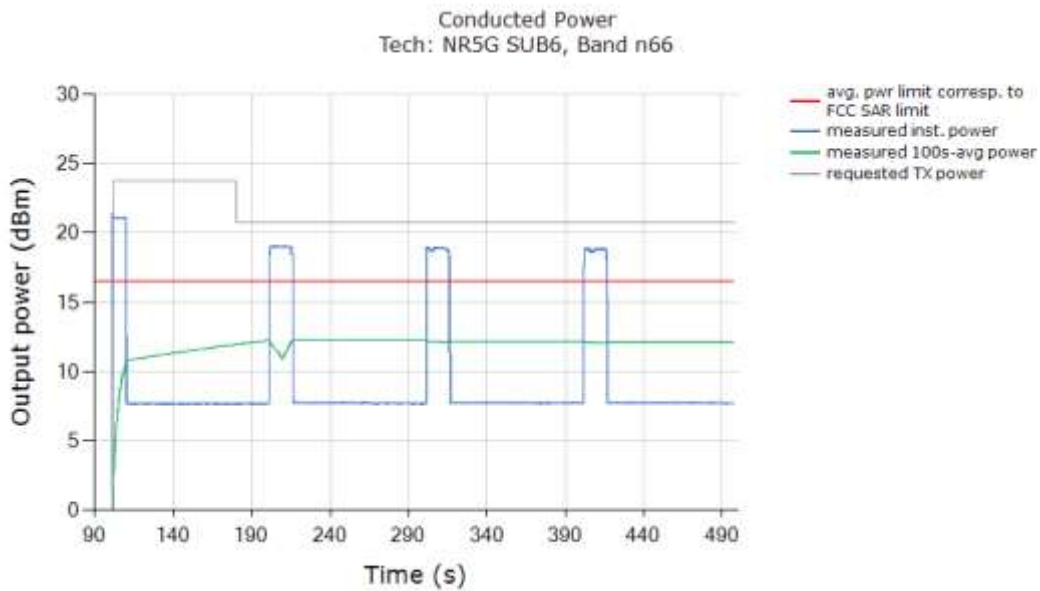


FCC		
Max 100s-time averaged 1gSAR (green curve)		0.818 W/kg
<p>Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of measured SAR at <i>Plimit</i> (last column in Table 7-2).</p>		

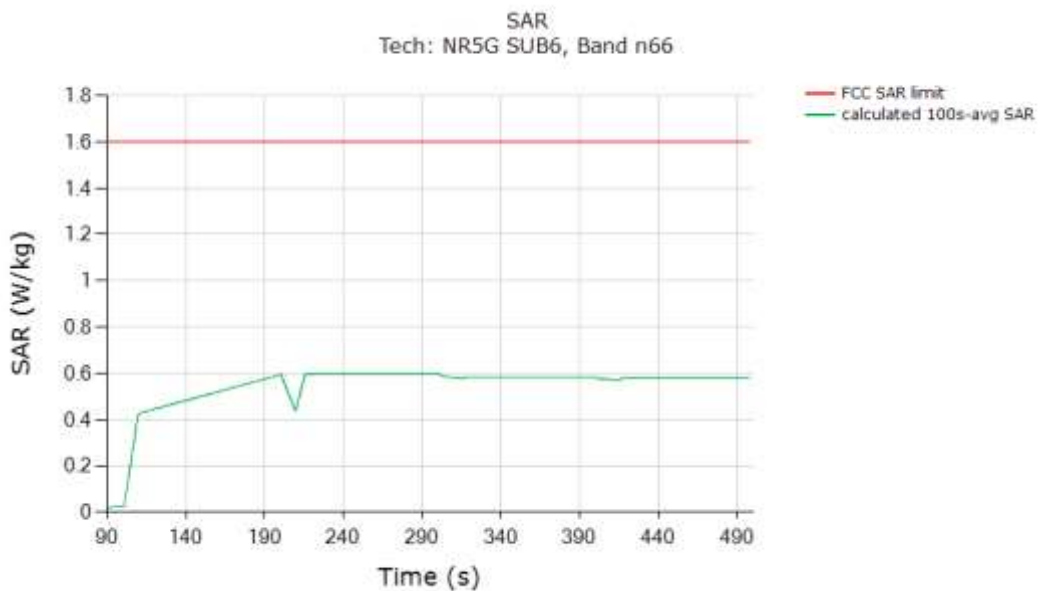
8.3.3 Sub6 NR n66 (test case 3 in Table 7-2)

Conducted Plot No. 3

Test result for test sequence 1:

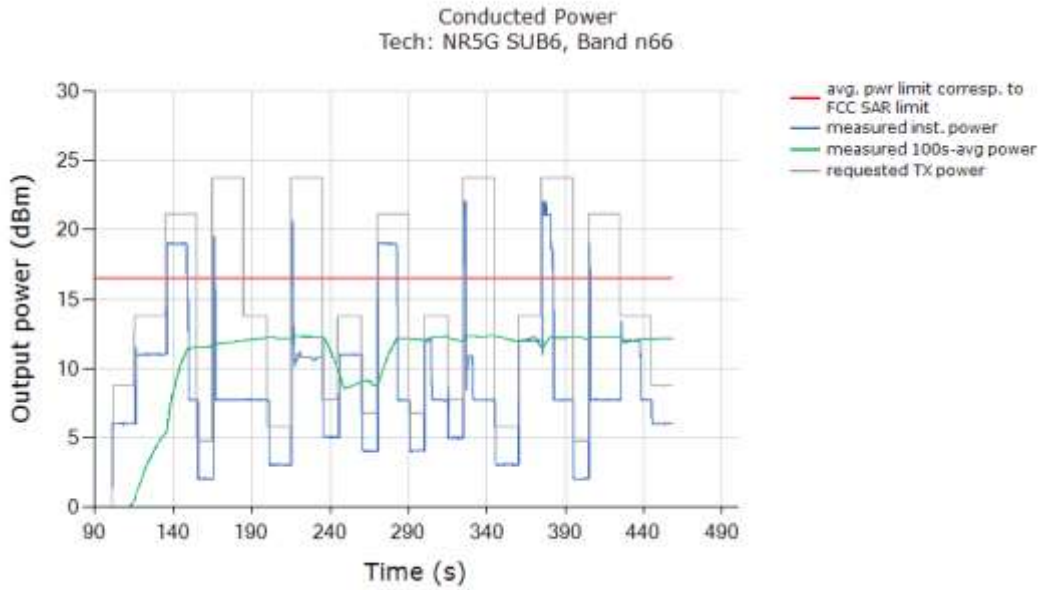


Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6kg for 1gSAR:

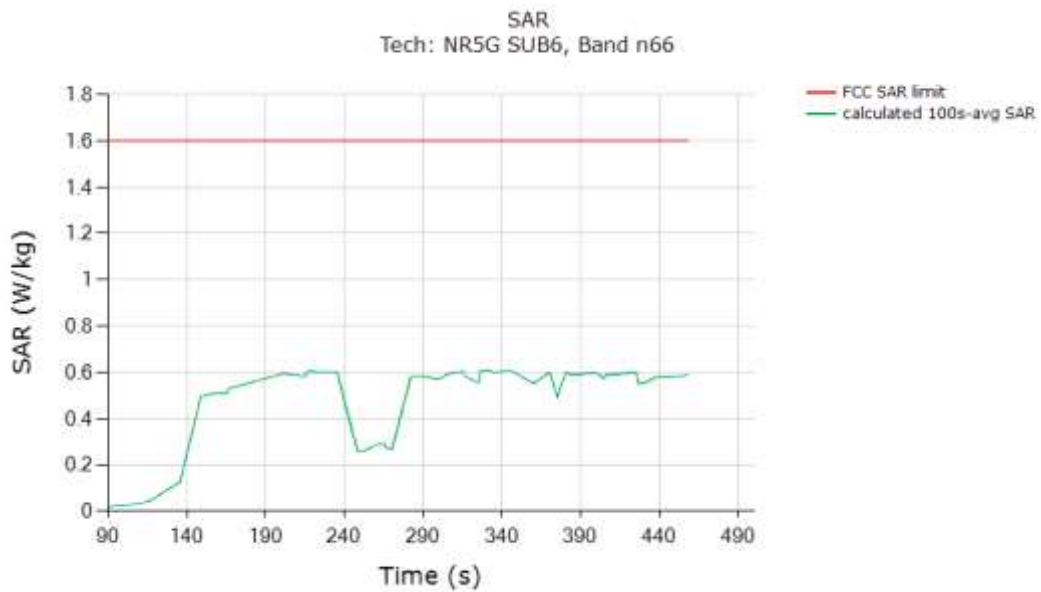


FCC 1g SAR limit	1.6 W/kg
Max 100s-time averaged 1gSAR (green curve)	0.598 W/kg
Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of measured SAR at <i>P</i> _{limit} (last column in Table 7-2).	

Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus



FCC 1gSAR limit	1.6 W/kg
Max 100s-time averaged 1gSAR (green curve)	0.608W/kg
Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of measured SAR at <i>P_{limit}</i> (last column in Table 7-2).	

time does not exceed the FCC limit of 1.6kg for 1gSAR:

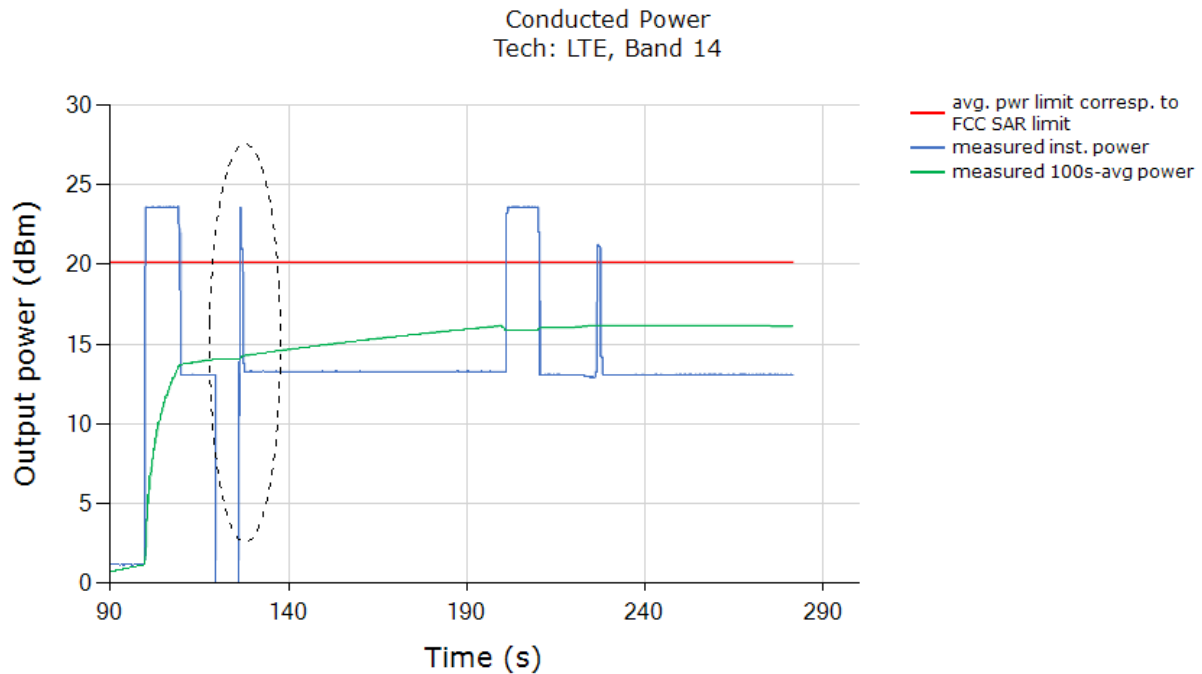
8.4 Change in Call Test results (test case 4 in Table 7-2)

This test was measured with LTE B14, DSI=1, and with callbox requesting maximum power. The call drop was manually performed when the EUT is transmitting at *Preserve* level as shown in the plot below (dotted black region). The measurement setup is shown in Figure 8-1(a) and (c). The detailed test procedure is described in Section 5.3.2.

Conducted Plot No. 4

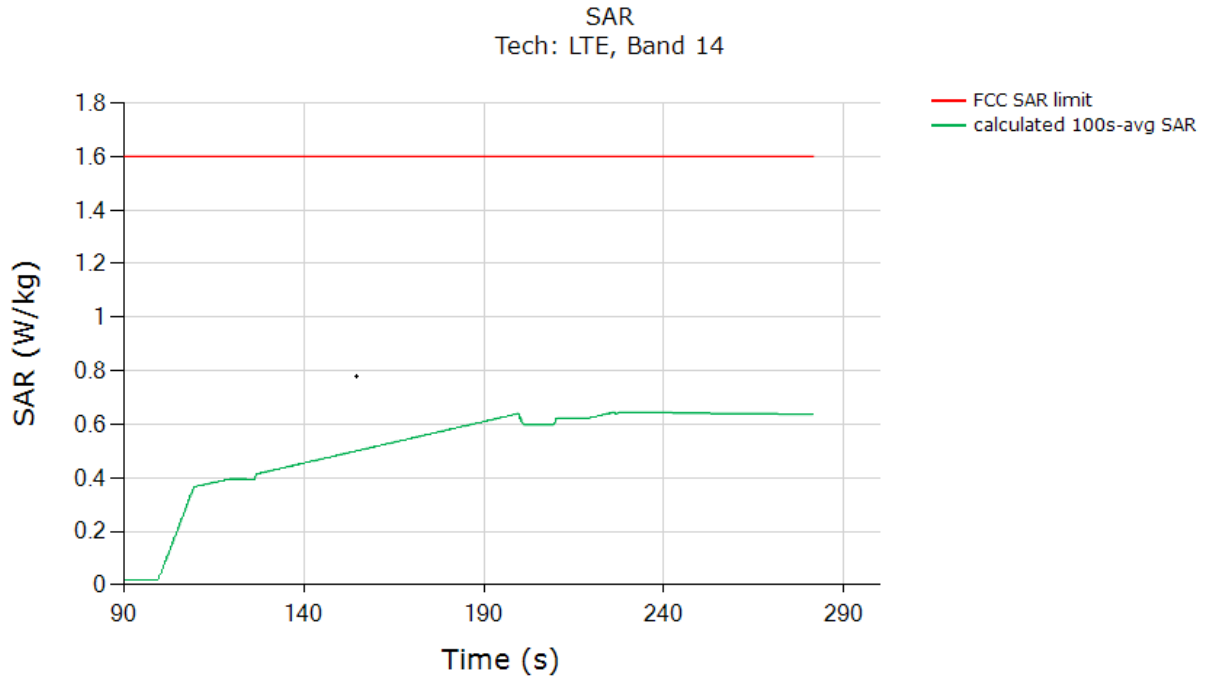
Call drop test result:

Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power kept the same *Preserve* level of LTE B14 after the call was re-established:



Note: The power level after the change in call kept the same *Preserve* level of LTE B14. The conducted power plot shows expected Tx transition.

Plot 2: Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



FCC 1gSAR limit	1.6 W/kg
Max 100s-time averaged 1gSAR (green curve)	0.644 W/kg
Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of measured SAR at <i>P_{limit}</i> (last column in Table 7-2).	

The test result validated the continuity of power limiting in call change scenario.

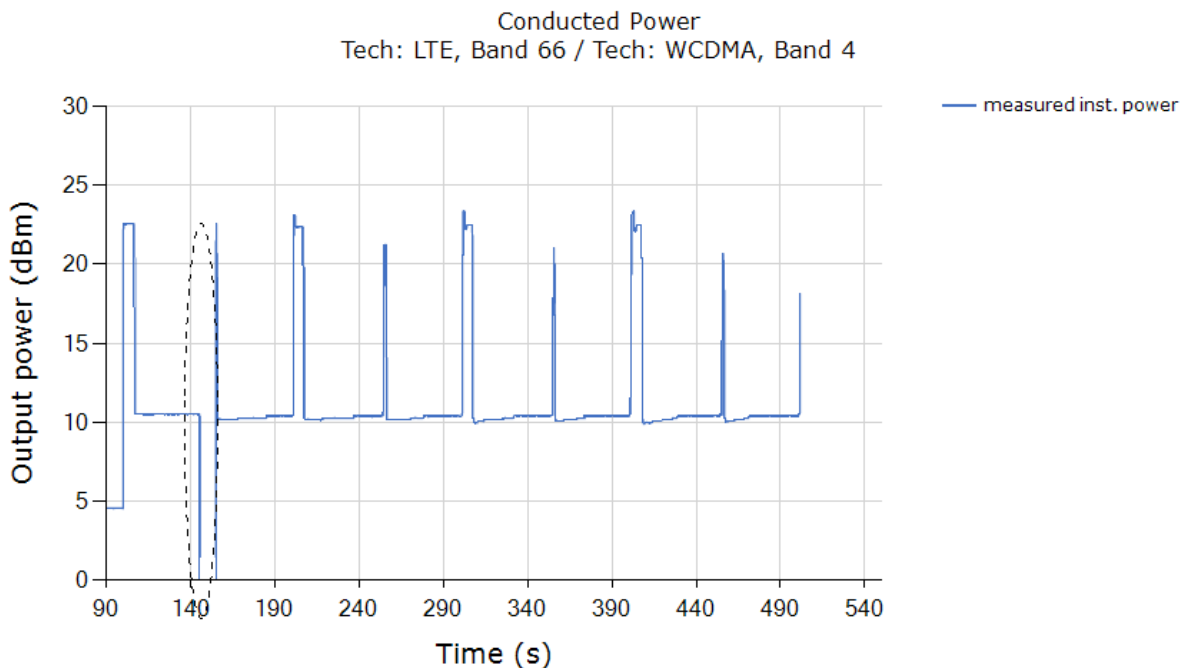
8.5 Change in technology/band test results (test case 5 in Table 7-2)

This test was conducted with callbox requesting maximum power, and with technology switch from LTE B66 , DSI = 1 (Grip) to WCDMA B4, DSI =1 (Grip). Following procedure detailed in Section 5.3.3, and using the measurement setup shown in Figure 8-1(a) the technology/band switch was performed when the EUT is transmitting at Preserve level as shown in the plot below (dotted black region).

Conducted Plot No. 5

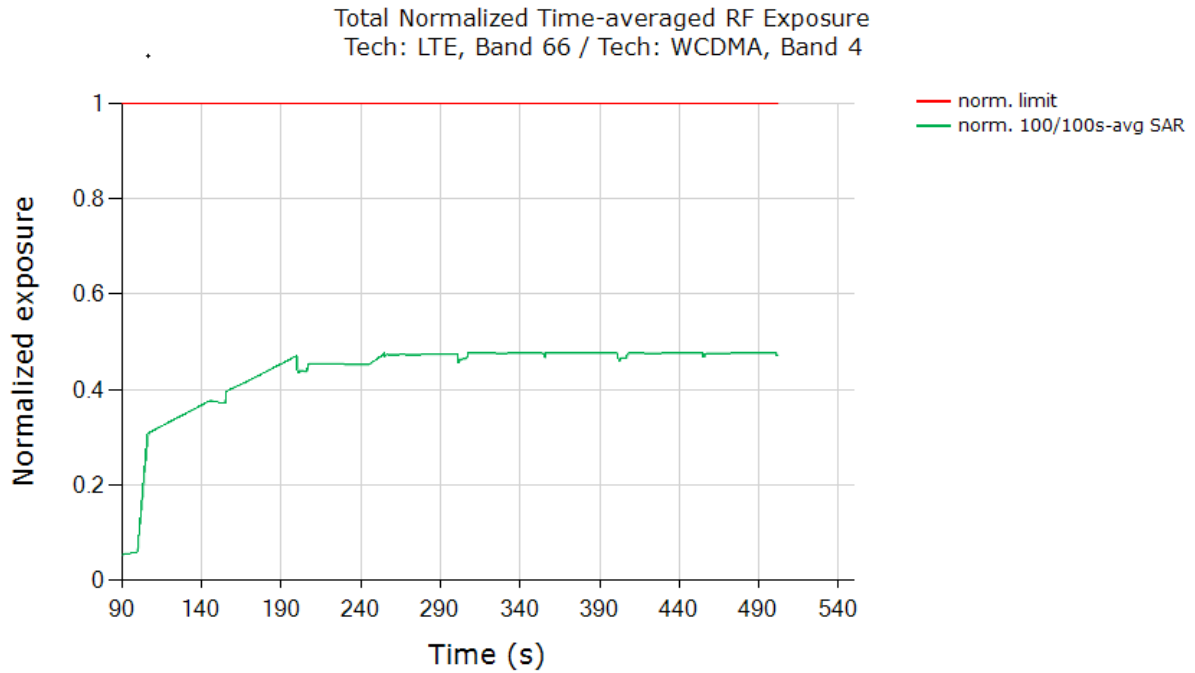
Test result for change in technology/band:

Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power changed from LTE B14, DSI =1 Preserve level to WCDMA B4, DSI = 1 Preserve level (within 1dB device uncertainty):



Note: As per Part 1 report, Reserve_power_margin = 3dB. Based on Table 7-1, EFS Plimit = 14dBm for LTE B66 (DSI=1), and EFS Plimit = 13.5 dBm for WCDMA B4 (DSI=1), it can be seen from above plot that the difference in Preserve (= Plimit – 3dB Reserve_power_margin) power level corresponds to the expected difference in Plimit levels of 0.5 dB (within 1dB of sub6 radio design related uncertainty). Therefore, the conducted power plot shows expected transition in Tx power.

Plot 2: All the time-averaged conducted Tx power measurement results were converted into time- averaged normalized SAR values using Equation (6a), (6b) and (6c), and plotted below to demonstrate that the time- averaged normalized SAR versus time does not exceed the normalized FCC limit of 1.0:



FCC normalized SAR limit	1.0 W/kg
Max 100s-time averaged normalized SAR (green curve)	0.477 W/kg
Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of measured SAR at <i>P_{limit}</i> (last column in Table 7-2).	

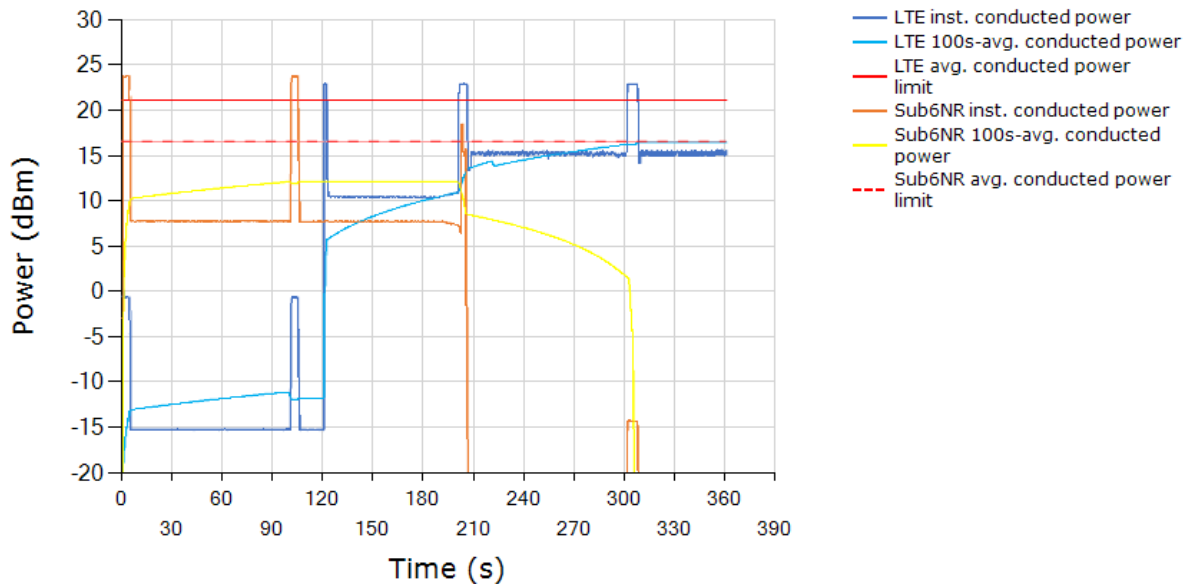
The test result validated the continuity of power limiting in technology/band switch scenario.

8.6 Switch in SAR exposure test results (test case 6 in Table 7-2)

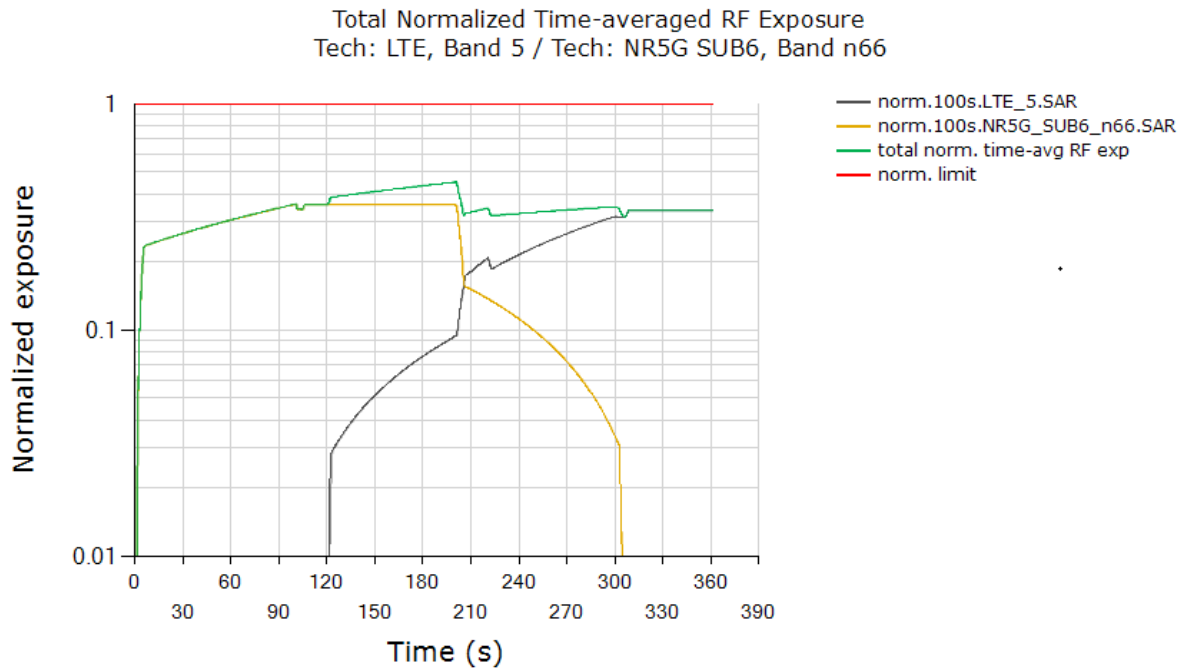
This test was conducted with callbox requesting maximum power, and with the EUT in LTE B5(26) + Sub6 NR Band n66 call. Here, LTE B5(26), DSI = 1 (100s window, EFS P_{limit} = 16.0 dBm, P_{max} = 24.5 dBm, measured P_{limit} = 16.0 dBm), and Sub6 NR Band n66, DSI = 1 (100s window, P_{limit} = 14.0 dBm in EFS setting, EUT's average P_{max} = 24.0 dBm, measured P_{limit} = 14.12 dBm). Following procedure detailed in Section 5.3.7 and Appendix B.2, and using the measurement setup shown in Figure 6-1(c) since LTE and Sub6 NR are sharing the same antenna port. The SAR exposure switch measurement is performed with the EUT in various SAR exposure scenarios, i.e., in SARsub6NR only scenario (t = 10s ~ 125s), SARsu6NR + SARLTE scenario (t = 125s ~ 245s) and SARLTE only scenario (t > 245s).

Conducted Plot No.6

LTE and mmW Instantaneous and Time-averaged TX Power
 Tech: LTE, Band 5 / Tech: NR5G SUB6, Band n66



Plot 2: All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (7a) is used to convert the LTE Tx power of device to obtain 100s-averaged normalized SAR in LTE B5(26) as shown in black curve. Similarly, equation (7b) is used to obtain 100s-averaged normalized SAR in Sub6 NR n66 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).



FCC 1gSAR limit	1.0 W/kg
Max time averaged normalized SAR (green curve)	0.452 W/kg
Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of measured SAR at <i>P</i> limit (last column in Table 7-2).	

Plot Notes:

Device starts predominantly in Sub6 NR SAR exposure scenario between 5s and 125s, and in LTE SAR + Sub6 NR SAR exposure scenario between 125s and 245s, and in predominantly in LTE SAR exposure scenario after t=245s. Here, Smart Transmit allocates a maximum of 75% of exposure margin (based on 3dB reserve margin setting) for Sub6 NR. This corresponds to a normalized 1gSAR exposure value = 75% * 0.847 W/kg measured SAR at Sub6 NR *P*limit / 1.6W/kg limit = 0.53± 1dB device related uncertainty (see orange curve between 5s~125s). For predominantly LTE SAR exposure scenario, maximum normalized 1gSAR exposure should correspond to 100% exposure margin = 0.486 W/kg measured SAR at LTE *P*limit / 1.6W/kg limit = 0.3 ± 1dB device related uncertainty (see black curve after t = 245s).

Additionally, in SAR exposure switch test, at all times the total time-averaged normalized RF exposure (green curve) should not exceed normalized SAR_design_target + 1dB device uncertainty. In this test, with a maximum normalized SAR of 0.452 being ≤ 0.79 (= 1.0/1.6 + 1dB device uncertainty), the above test result validated the continuity of power limiting in SAR exposure switch scenario.

9. Radiated Power Test Results for mmW Smart Transmit Feature Validation

9.1 Measurement Setup

The Keysight Technologies E7515B UXM callbox is used in this test. The test setup is shown in Figure 9-1a and the schematic of the setup is shown in Figure 9-1b (see Appendix E : Test setup photo-6 for PD). The UXM callbox has two RF radio heads to up/down convert IF to mmW frequencies, which in turn are connected to two horn antennas for V- and H-polarizations for downlink communication. In the uplink, a directional coupler is used in the path of one of the horn antennas to measure and record radiated power using a Rohde & Schwarz NR40S power sensor and NRP2 power meter. Note here that the isolation of the directional coupler may not be sufficient to attenuate the downlink signal from the callbox, which will result in high noise floor masking the recording of radiated power from EUT. In that case, either lower the downlink signal strength emanating from the RF radio heads of callbox or add an attenuator between callbox radio heads and directional coupler. Additionally, note that since the measurements performed in this validation are all relative, measurement of EUT’s radiated power in one polarization is sufficient. The EUT is placed inside an anechoic chamber with V- and H-pol horn antennas to establish the radio link as shown in Figure 9-1. The callbox’s LTE port is directly connected to the EUT’s RF port via a directional coupler to measure the EUT’s conducted Tx power using a Rohde & Schwarz NR8S power sensor and NRP2 power meter. Additionally, EUT is connected to the PC via USB connection for sending beam switch command. Care is taken to route the USB cable and RF cable (for LTE connection) away from the EUT’s mmW antenna modules.

Setup in Figure 9-1 is used for the test scenario 1, 4 and 5 described in Section 4. The test procedures described in Section 6 are followed. The path losses from the EUT to both the power meters are calibrated and used as offset in the power meter.

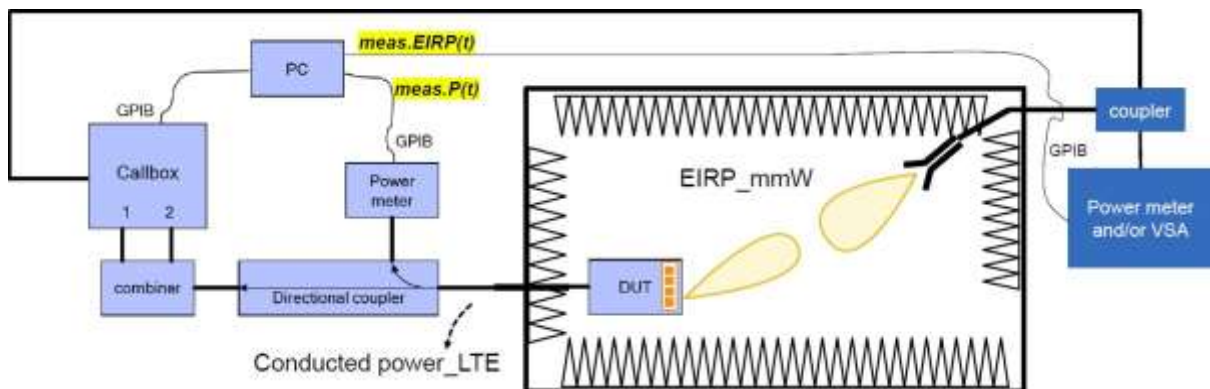


Figure 9-1 mmW NR radiated power measurement setup (see Appendix E for missing figures)

Both the callbox and power meters are connected to the PC using USB cables. Test scripts are custom made for automation of establishing LTE + mmW call, conducted Tx power recording for LTE and radiated Tx power recording for mmW. These tests are manually stopped after desired time duration. Test script is programmed to set LTE Tx power to all-down bits on the callbox immediately after the mmW link is established, and programmed to set toggle between all-up and all-down bits depending on the transmission scenario being evaluated. Similarly, test script is also programmed to send beam switch command manually to the EUT via USB connection. For all the tests, the callbox is set to request maximum Tx power in mmW NR radio from EUT all the time.

Test configurations for this validation are detailed in Section 7.2. Test procedures are listed in Section 6.3.

9.2 mmW NR radiated power test results

To demonstrate the compliance, the conducted Tx power of LTE B2 in DSI = 1 (Grip mode) is converted to 1gSAR exposure by applying the corresponding worst-case 1gSAR value at *P_{limit}* as reported in Part 1 report and listed in Table 7-2 of this report.

Similarly, following Step 4 in Section 6.3.1, radiated Tx power of mmW Band n261 for the beams tested is converted by applying the corresponding worst-case 4cm²PD values measured in HCT lab, and listed in below Table 9-1. Qualcomm Smart Transmit feature operates based on time-averaged Tx power reported on a per symbol basis, which is independent of modulation, channel and bandwidth (RBs), therefore the worst-case 4cm²PD was conducted with the EUT in FTM mode, with CW modulation and 100% duty cycle. cDASY6 system verification for power density measurement is provided in Appendix C, and the associated SPEAG certificates are attached in Appendix D.

Both the worst-case 1gSAR and 4cm²PD values used in this section are listed in Table 9-1. The measured EIRP at *input.power.limit* for the beams tested in this section are also listed in Table 9-1

Table 9-1:

Worst-case 1gSAR, 4cm² avg. PD and EIRP measured at *input.power.limit* for the selected configurations

Worst-case 1gSAR, 4cm² avg. PD and EIRP measured at *input.power.limit* for the selected configurations

Tech	Band	Antenna	Beam ID	input.power.limit (dBm)	meas. 4cm ² PD		meas. EIRP at input.power.limit (dBm)
					at input.power.limit (W/m ²)	Configuration	
mmW NR	n261	K Patch (Module 0)	152	2.5	5.63	Front	14.45
			14	2.4	3.79	Front	12.45
			0	8.6	3.73	Front	7.53

Tech	Band	Antenna	DSI	meas. P _{limit} (dBm)	Measured 1g SAR at P _{limit}	
					at P _{limit} (W/kg)	Configuration
LTE	LTE2(25)	Main 1	1	14.97	0.68	Rear

The 4cm²-averaged PD distributions for the highest PD value per band, as listed in Table 9-1, are plotted below:

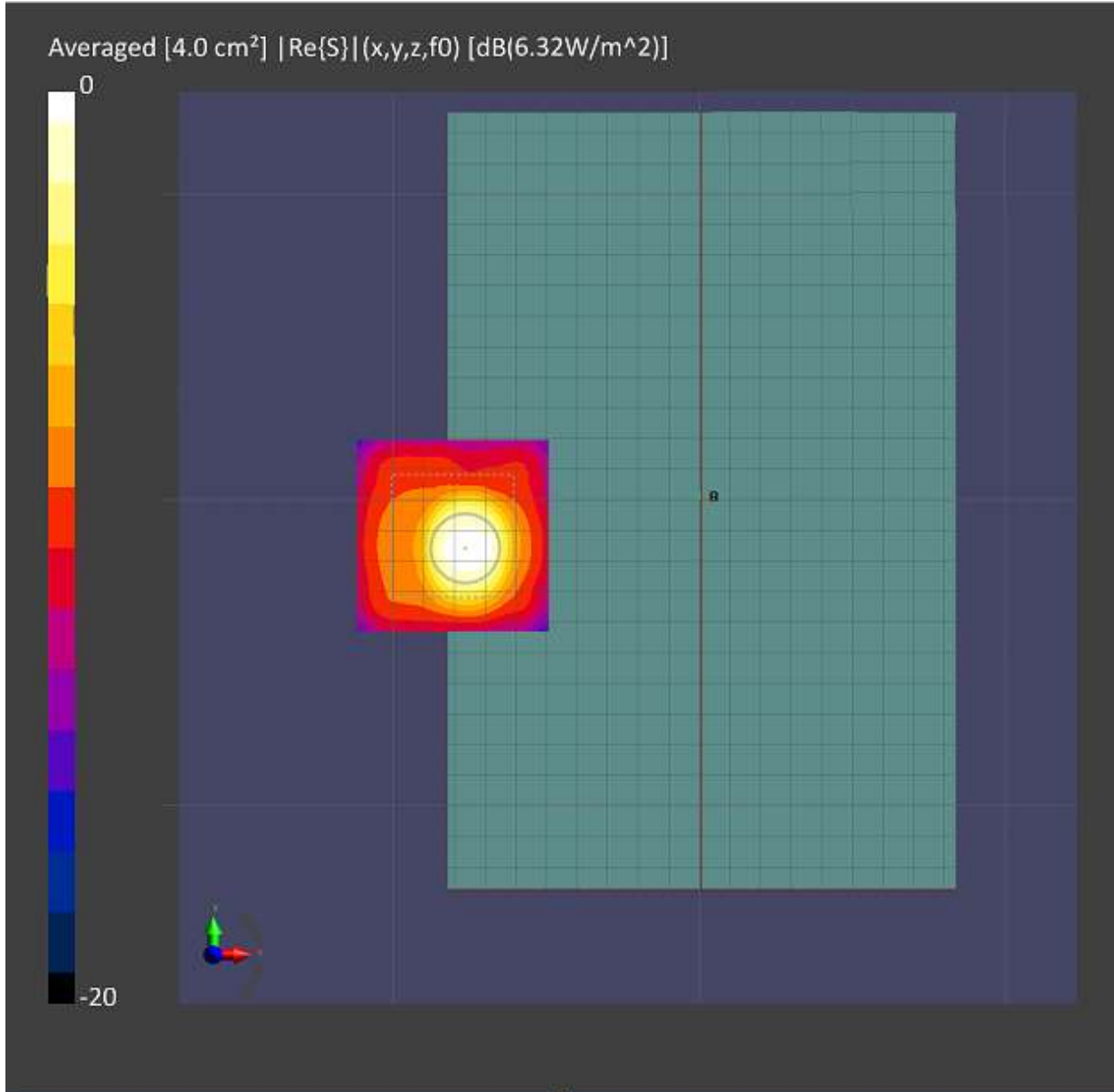


Figure 9-2: 4cm²-averaged power density distribution measured at *input.power.limit* of 2.5 dBm on the Front surface for n261 beam 152

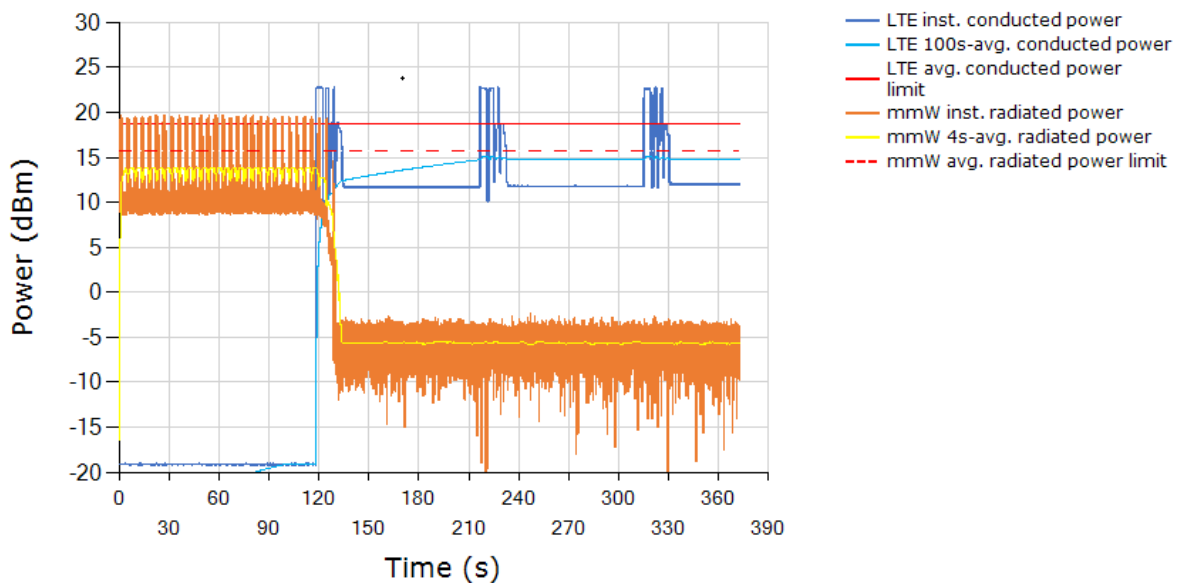
9.2.1 Maximum Tx power test results for n261(test case 7 in table 7-3)

This test was measured with LTE B2(25) (DSI = 1) and mmW Band n261 Beam ID 152 by following the detailed test procedure described in Section 6.3.1.

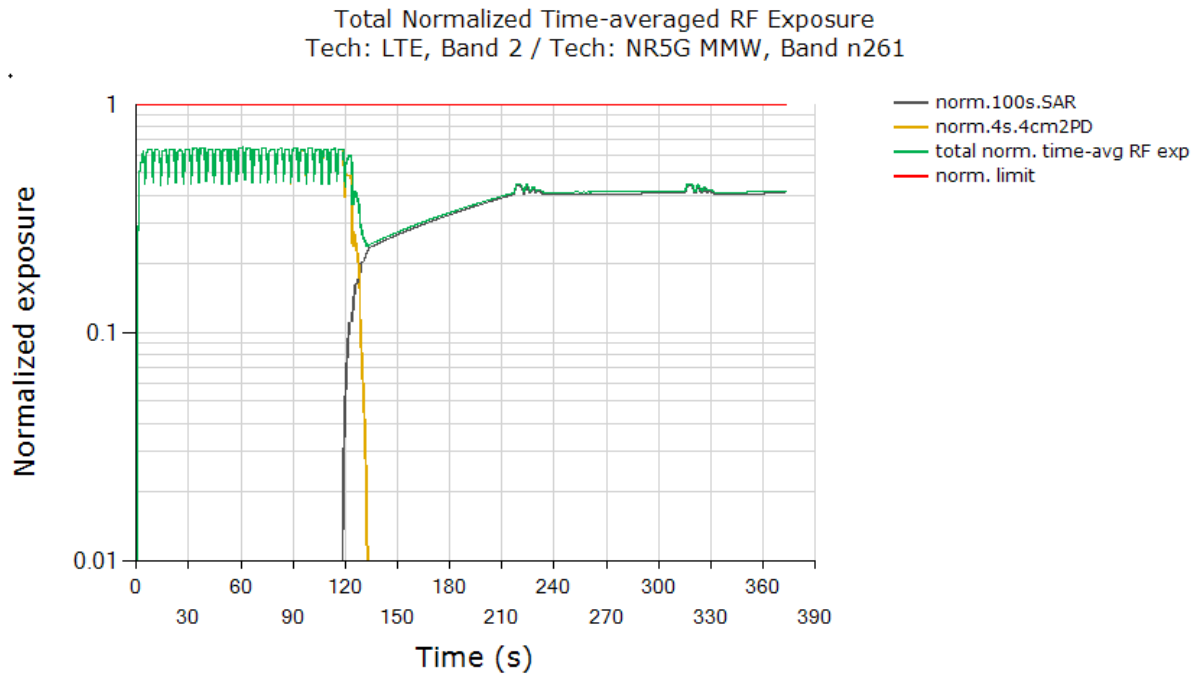
Instantaneous and 100s-averaged conducted LTE Tx power versus time, instantaneous and 4s- averaged radiated mmW Tx power versus time, time-averaged conducted LTE Tx power limit and time-averaged radiated mmW Tx power limit:

Radiation Plot No. 7

LTE and mmW Instantaneous and Time-averaged TX Power
 Tech: LTE, Band 2 / Tech: NR5G MMW, Band n261



Above time-averaged conducted Tx power for LTE B2(25) and radiated Tx power for mmW NR n261 beam 152 are converted into time-averaged 1gSAR and time-averaged 4cm2PD using Equation (2a) and (2b), which are divided by FCC 1g SAR limit of 1.6 W/kg and 4cm2PD limit of 10 W/m2, respectively, to obtain normalized exposures versus time. Below plot shows (a) normalized time-averaged 1gSAR versus time, (b) normalized time-averaged 4cm2-avg.PD versus time, (c) sum of normalized time-averaged 1gSAR and normalized time-averaged 4cm2- avg.PD:



FCC requirement for total RF exposure (normalized)	1.0 W/kg
Max total normalized time-averaged RF exposure (green curve)	0.650 W/kg
Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of measured SAR at Plimit (last column in Table 7-2).	

Plot notes:

As soon as 5G mmW NR call was established, LTE was placed in all-down bits immediately. Between 0s~120s, mmW exposure is the dominant contributor. Here, Smart Transmit feature allocates a maximum of 75% for mmW (based on the 3dB reserve setting in Part 1 report). From Table 9-1, this corresponds to a normalized 4cm²PD exposure value for Beam ID 152 of $(75\% * 5.63 \text{ W/m}^2) / (10 \text{ W/m}^2) = 42.2\% \pm 2.1\text{dB}$ device related uncertainty. (see green/orange curve between 0s~120s). At ~120s time mark, LTE is set to all-up bits, taking away margin from mmW exposure gradually. Towards the end of test, LTE is the dominant contributor towards RF exposure, i.e., corresponding normalized 1gSAR exposure value of $(100\% * 0.68 \text{ W/kg}) / (1.6 \text{ W/kg}) = 42.5\% \pm 1\text{dB}$ design related uncertainty. (see black curve approaching this level towards end of the test).

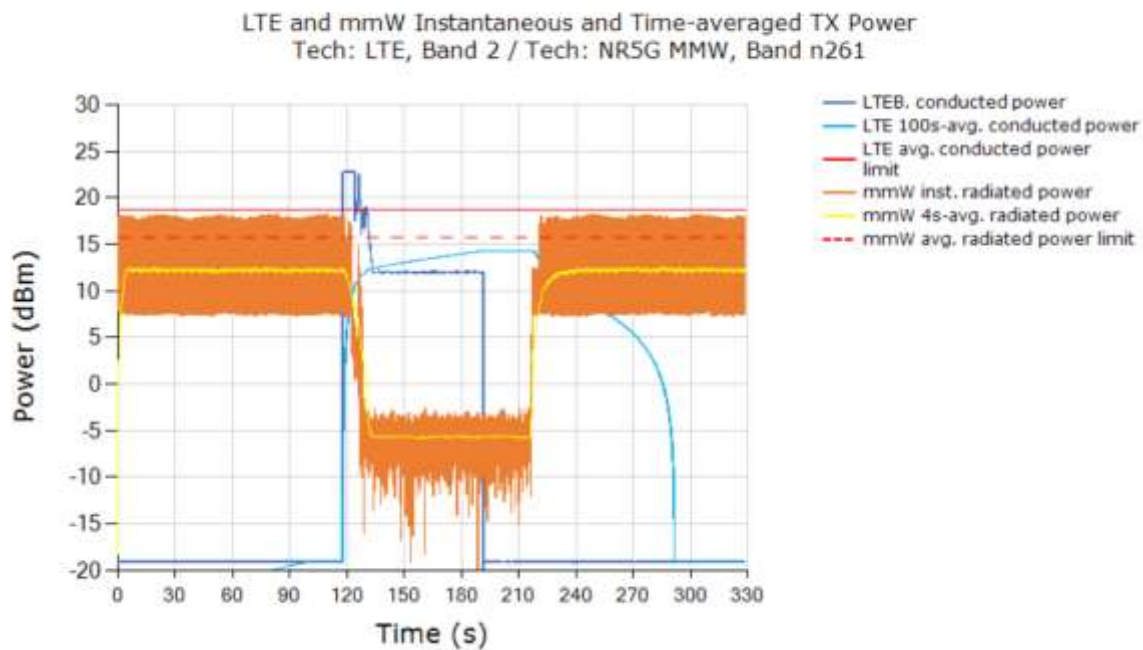
As can be seen, the power limiting enforcement is effective and the total normalized time- averaged RF exposure does not exceed 1.0. Therefore, Qualcomm® Smart Transmit time averaging feature is validated.

9.2.2 Switch in SAR vs. PD test results for n261 (Test case 8 in table 7-3)

This test was measured with LTE Band 2 (DSI =1) and mmW Band n261 Beam ID 152, by following the detailed test procedure is described in Section 6.3.2.

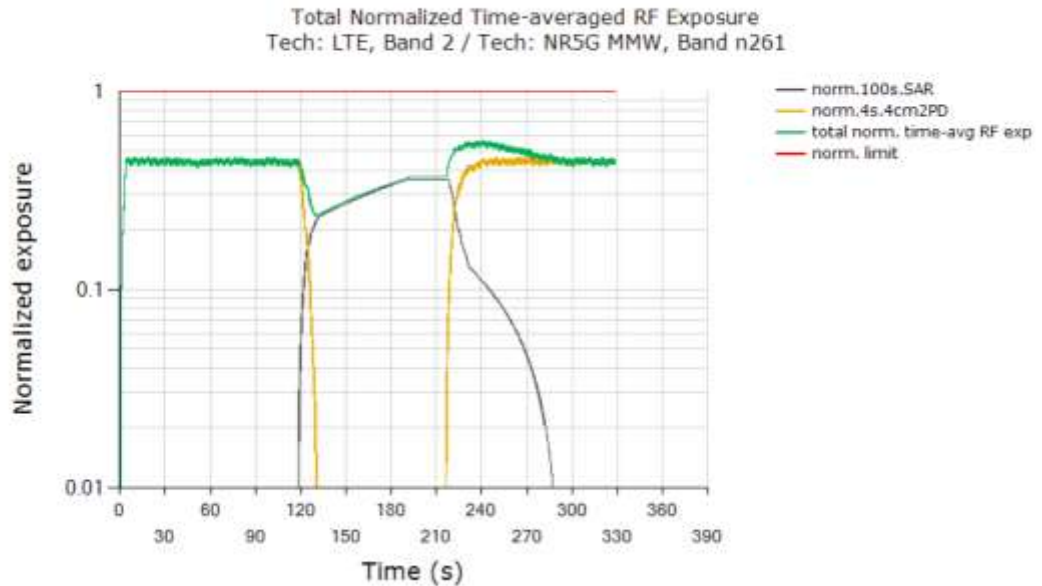
Instantaneous and 100s-averaged conducted LTE Tx power versus time, instantaneous and 4s- averaged radiated mmW Tx power versus time, time-averaged conducted LTE Tx power limit and time-averaged radiated mmW Tx power limit:

Radiation Plot No. 8



From the above plot, it is predominantly instantaneous PD exposure between 0s ~ 120s, it is instantaneous SAR+PD exposure between 120s ~ 160s, it is predominantly instantaneous SAR exposure between 160s ~ 200s, and above 200s, it is predominantly instantaneous PD exposure.

Normalized time-averaged exposures for LTE (1gSAR) and mmW (4cm2PD), as well as total normalized time-averaged exposure versus time:



FCC requirement for total RF exposure (normalized)	1.0 W/kg
Max total normalized time-averaged RF exposure (green curve)	0.566 W/kg
Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of measured SAR at Plimit (last column in Table 7-2).	

Plot notes:

As soon as 5G mmW NR call was established, LTE was placed in all-down bits immediately. Between 0s~120s, mmW exposure is the dominant contributor. Here, Smart Transmit feature allocates a maximum of 75% for mmW (based on 3dB reserve setting in Part 1 report). From Table 9-1, this corresponds to a normalized 4cm²PD exposure value for Beam ID 152 of $(75\% * 5.63 \text{ W/m}^2)/(10 \text{ W/m}^2) = 42.2\% \pm 2.1\text{dB}$ device related uncertainty (see orange/green curve between 0s~120s). At ~120s time mark, LTE is set to all-up bits, taking away margin from mmW exposure gradually (orange curve for mmW exposure goes down while black curve for LTE exposure goes up). At ~200s time mark, LTE is set to all-down bits, which results in mmW getting back RF margin slowly as seen by gradual increase in mmW exposure (orange curve for mmW exposure goes up while black curve for LTE exposure goes down). The calculated maximum RF exposure from LTE corresponds to normalized 1gSAR exposure value of $(100\% * 0.680\text{W/kg})/(1.6 \text{ W/kg}) = 42.5\% \pm 1\text{dB}$ design related uncertainty (note that this level will be achieved by green and black curves if LTE remains in all-up bits for longer time duration which was already demonstrated in maximum Tx power test in Section 10.2.1). Total normalized time-averaged exposure (green curve) for this test should be within the calculated range between $42.2\% \pm 2.1\text{dB}$ device related uncertainty (only PD exposure) and $42.5\% \pm 1\text{dB}$ design related uncertainty (only SAR exposure).

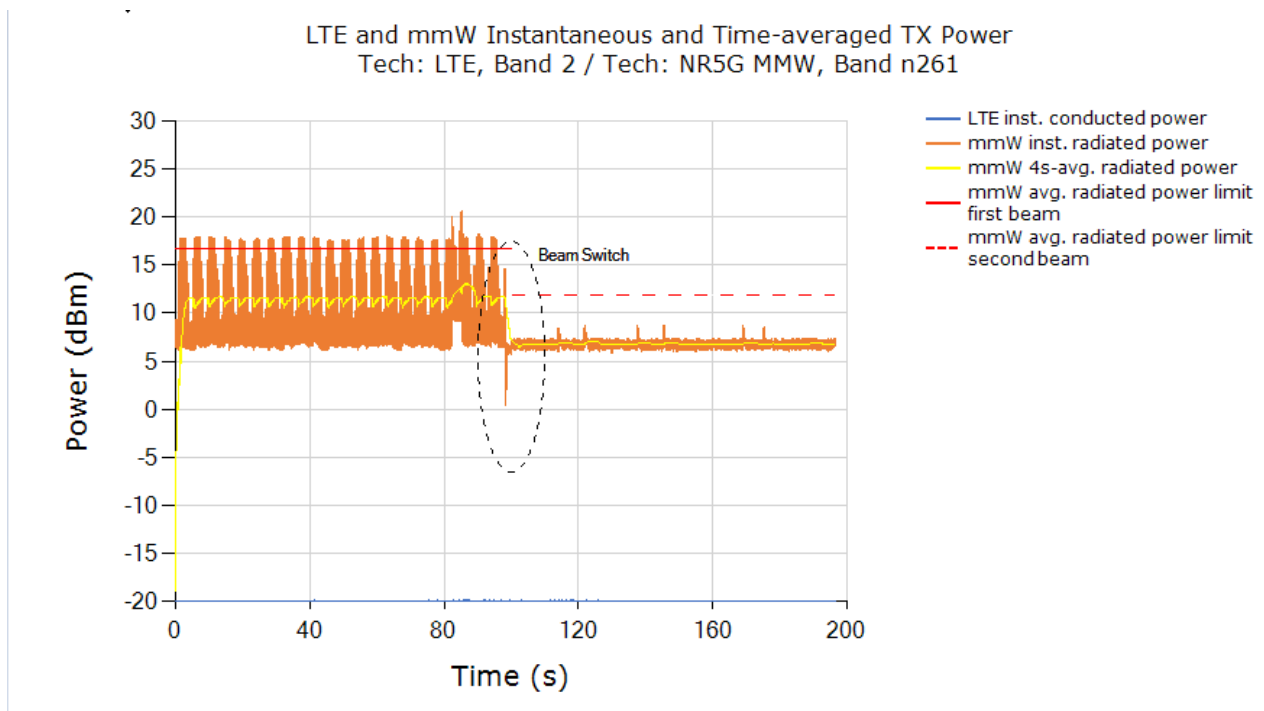
As can be seen, the power limiting enforcement is effective during transmission when SAR and PD exposures are switched, and the total normalized time-averaged RF exposure does not exceed 1.0. Therefore, Qualcomm® Smart Transmit time averaging feature is validated.

9.2.3 Change in Beam test results for n261(Test case 9 in table 7-3)

This test was measured with LTE Band 2 (DSI = 1) and mmW Band n261, with beam switch from Beam ID 14 to Beam ID 0, by following the test procedure is described in Section 6.3.3.

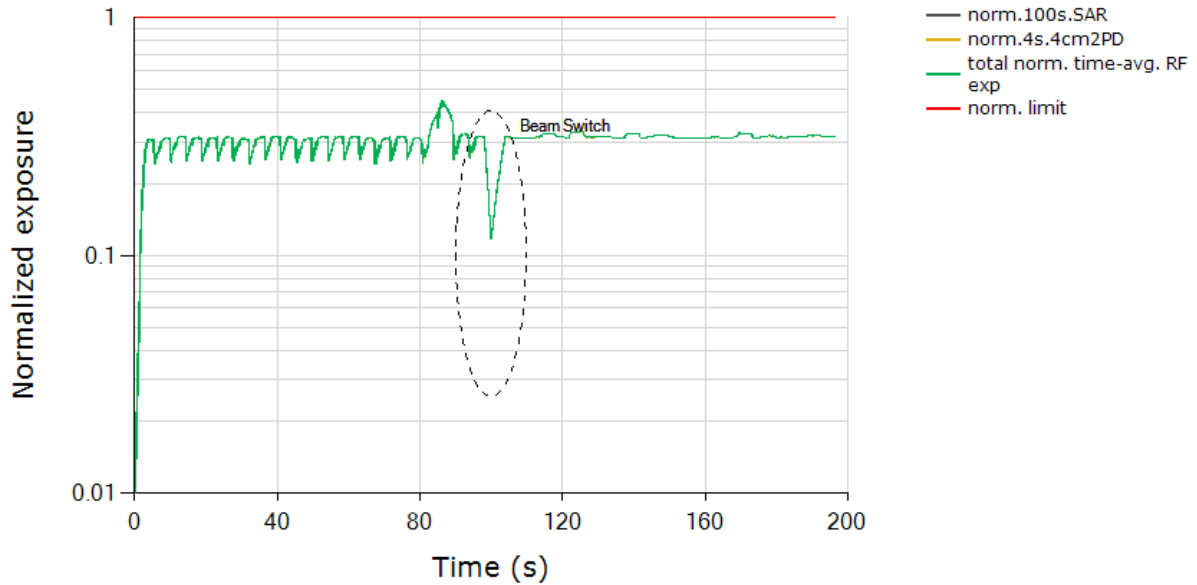
Instantaneous conducted LTE Tx power versus time, instantaneous and 4s-averaged radiated mmW Tx power versus time, time-averaged radiated mmW Tx power limits for beam 14 and beam 0

Radiation Plot No. 9



Normalized time-averaged exposures for LTE and mmW (4cm2PD), as well as total normalized time-averaged exposure versus time:

Total Normalized Time-averaged RF Exposure
 Tech: LTE, Band 2 / Tech: NR5G MMW, Band n261



FCC requirement for total RF exposure (normalized)	1.0 W/kg
Max total normalized time-averaged RF exposure (green curve)	0.448 W/kg
Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of measured SAR at Plimit (last column in Table 7-2).	

Plot notes: 5G mmW NR call was established at ~1s time mark and LTE was placed in all-down bits immediately after 5G mmW NR call was established. For the rest of this test, mmW exposure is the dominant contributor as LTE is left in all-down bits. Here, Smart Transmit feature allocates a maximum of 75% for mmW (based on 3dB reserve setting in Part 1 report). From Table 9-1, exposure between 1s ~100s corresponds to a normalized 4cm2PD exposure value for Beam ID 14 of $(75\% * 3.79 \text{ W/m}^2)/(10 \text{ W/m}^2) = 28.4\% \pm 2.1\text{dB}$ device related uncertainty. At ~100s time mark (shown in black dotted ellipse), beam was switched to Beam ID 0. Note that the input.power.limit for Beam ID 0 is 8.6 dBm, $(75\% * 3.73 \text{ W/m}^2)/(10 \text{ W/m}^2) = 28.0\% \pm 2.1\text{dB}$ device related uncertainty

Additionally, during the switch, the ratio between the averaged radiated powers of the two beams (yellow curve) should correspond to the difference in EIRPs measured at each corresponding input.power.limit for these beams listed in Table 9-1

10. Equipment List

Manufacturer	Type / Model	S/N	Calib. Date	Calib.Interval	Calib.Due
SPEAG	SAM Phantom	-	N/A	N/A	N/A
HP	SAR System Control PC	-	N/A	N/A	N/A
Staubli	Robot RX90B L	F01/ 5K08A1/ A/ 01	N/A	N/A	N/A
Staubli	Robot Controller CS8Cspeag-TX90	F17/ 59RAA1/ C/ 01	N/A	N/A	N/A
Staubli	Joystick D21142606B	011578	N/A	N/A	N/A
SPEAG	DAE4	652	02/03/2020	Annual	02/03/2021
SPEAG	DAE4	869	09/19/2019	Annual	09/19/2020
SPEAG	E-Field Probe EX3DV4	3903	03/25/2020	Annual	03/25/2020
SPEAG	E-Field Probe EUmmWV3	9382	07/25/2019	Annual	07/25/2020
SPEAG	Dipole D1800V2	2d015	09/19/2019	Annual	09/19/2020
SPEAG	Dipole D1900V2	5d061	01/21/2020	Annual	01/21/2021
Keysight Technologies	UXM 5G Wireless Test Platform	E7515B	05/28/2020	Annual	05/28/2021
R&S	3-PATH DIODE Power Sensor	108076	04/22/2020	Annual	04/22/2021
R&S	Power Sensor	NRP40S	04/22/2020	Annual	04/22/2021
Narda	Directional Coupler	03096	04/14/2020	Annual	04/14/2021
Narda	Directional Coupler	03089	04/13/2020	Annual	04/13/2021
Mini-circuits	Power Splitter	ZN2PD2-63-S+	04/17/2020	Annual	04/17/2021
SPEAG	5G Verification Source 30 GHz	1011	07/17/2019	Annual	07/17/2020
Agilent	Power Meter E4419B	MY41291386	10/07/2019	Annual	10/07/2020
Agilent	Power Meter N1911A	MY45101406	09/10/2019	Annual	09/10/2020
EM POWER	Power Amp BBS5K8CAJ	1011	10/08/2019	Annual	10/08/2020
EM POWER	Power Amp EG0842-13	1009D/C0028	10/08/2019	Annual	10/08/2020
Agilent	Power Sensor N1921A	MY55220026	09/06/2019	Annual	09/06/2020
Agilent	Power Sensor(H) 8481A	MY41090873	10/07/2019	Annual	10/07/2020
SPEAG	DAKS 3.5	1038	03/24/2020	Annual	03/24/2021
SPEAG	DAKS_VNA R140	0141013	04/06/2020	Annual	04/06/2021
Agilent	Directional Bridge 86205A	3140A03878	06/09/2020	Annual	06/09/2021
HP	Signal Generator 8664A	3744A02069	10/07/2019	Annual	10/07/2020
Agilent	Signal Generator N5182A	MY46240807	12/02/2019	Annual	12/02/2020
Agilent	MXA Signal Analyzer N9020A	MY50510407	10/29/2019	Annual	10/29/2020
R&S	Wireless Communication Test Set CMW500	115733	05/14/2020	Annual	05/14/2021
Apitech	Attenuator (3dB) 8693B	MY39260298	09/18/2019	Annual	09/18/2020
HP	Attenuator (20dB) 33340C	18128	03/05/2020	Annual	03/05/2021
KEYSIGHT	mmWave Transceiver	MY58270633	07/08/2019	Annual	07/08/2020

11. Measurement Uncertainties

For PD Measurement

Measurement Uncertainty for CDASY6 mmWave module						
<i>a</i>	<i>b</i>	<i>c</i>	<i>d</i>	<i>e</i>	$f = \frac{b \times e}{d}$	<i>g</i>
Source of uncertainty	Uncertainty Value (± dB)	Probability distribution	Div.	<i>c_i</i>	Standard Uncertainty <i>y</i> (± dB)	<i>v_i</i>
Probe calibration	0.49	N	1	1	0.49	∞
Probe correction	0.00	R	1.73	1	0.00	∞
Frequency Response(BW≤ 1GHz)	0.20	R	1.73	1	0.12	∞
Sensor cross coupling	0.00	R	1.73	1	0.00	∞
Istropy	0.50	R	1.73	1	0.29	∞
Linearity	0.20	R	1.73	1	0.12	∞
Probe scattering	0.00	R	1.73	1	0.00	∞
Probe positioning offset	0.30	R	1.73	1	0.17	∞
Probe positioning Repeatability	0.04	R	1.73	1	0.02	∞
Probe spatial Resolution	0.00	R	1.73	1	0.00	∞
Field Impedence Dependence	0.00	R	1.73	1	0.00	∞
Sensor Mechanical Offset	0.00	R	1.73	1	0.00	∞
Amplitude and Phase drift	0.00	R	1.73	1	0.00	∞
Amplitude and Phase noise	0.04	R	1.73	1	0.02	∞
Measurement area truncation	0.00	R	1.73	1	0.00	∞
System Detection Limit	0.04	R	1.73	1	0.02	∞
Data acquisition	0.03	N	1	1	0.03	∞
Field Reconstruction	0.60	R	1.73	1	0.35	∞
Forward Transformation	0.00	R	1.73	1	0.00	∞
Power density Scailing	0.00	R	1.73	1	0.00	∞
Spatial Averaging	0.10	R	1.73	1	0.06	∞
Test sample and Environmental Factors						
Probe coupling with DUT	0.00	R	1.73	1	0.00	∞
Modulation Response	0.40	R	1.73	1	0.23	∞
Integration time	0.00	R	1.73	1	0.00	∞
Response time	0.00	R	1.73	1	0.00	∞
Device holder influence	0.10	R	1.73	1	0.06	∞
DUT alignment	0.00	R	1.73	1	0.00	∞
RF Ambient Conditions	0.04	R	1.73	1	0.02	∞
RF ambient - reflections	0.04	R	1.73	1	0.02	∞
Immunity/Secondary Reception	0.00	R	1.73	1	0.00	∞
Power Drif of DUT	0.22	R	1.73	1	0.13	∞
Combined standard uncertainty (k = 1)		RSS			0.76	∞

12. Conclusion

Qualcomm Smart Transmit feature employed in Samsung Tablet (FCC ID:A3LSMT878U) has been validated through the conducted/radiated power measurement (as demonstrated in Chapters 8 and 10), as well as SAR and PD measurement (as demonstrated in Chapters 9 and 11).

As demonstrated in this report, the power limiting enforcement is effective and the total normalized time-averaged RF exposure does not exceed 1.0 for all the transmission scenarios described in Section 4.

Therefore, the EUT complies with FCC RF exposure requirement.

Appendix A: Test Sequences

1. Test sequence is generated based on below parameters of the EUT:

- a. Measured maximum power (P_{max})
- b. Measured Tx_power_at_SAR_design_target (P_{limit})
- c. Reserve_power_margin (dB)

$$P_{reserve} \text{ (dBm)} = \text{measured } P_{limit} \text{ (dBm)} - \text{Reserve_power_margin (dB)}$$

- d. SAR_time_window (100s for FCC)

2. Test Sequence 1 Waveform:

Based on the parameters above, the Test Sequence 1 is generated with one transition between high and low Tx powers. Here, high power = P_{max} ; low power = $P_{max}/2$, and the transition occurs after 80 seconds at high power P_{max} . As long as the power enforcement is taking into effective during one 100s/60s time window, the validation test with this defined test sequence 1 is valid, otherwise, select other radio configuration (band/DSI within the same technology group) having lower P_{limit} for this test. The Test sequence 1 waveform is shown below:

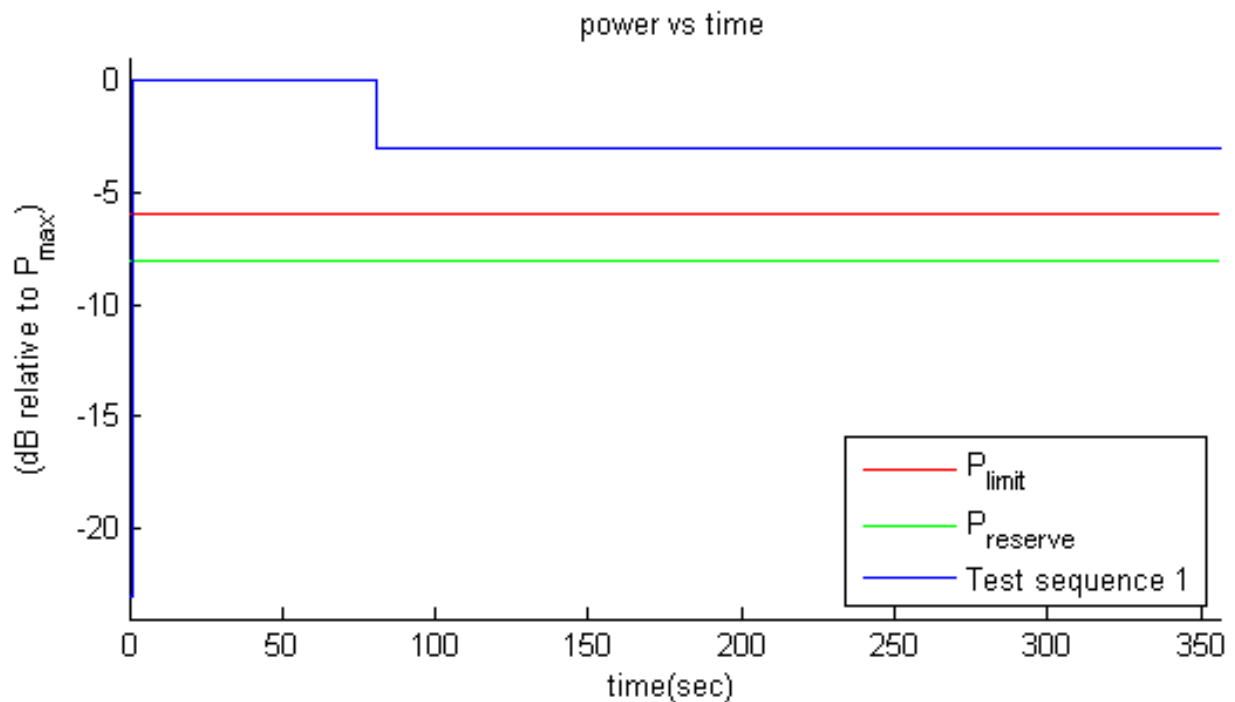


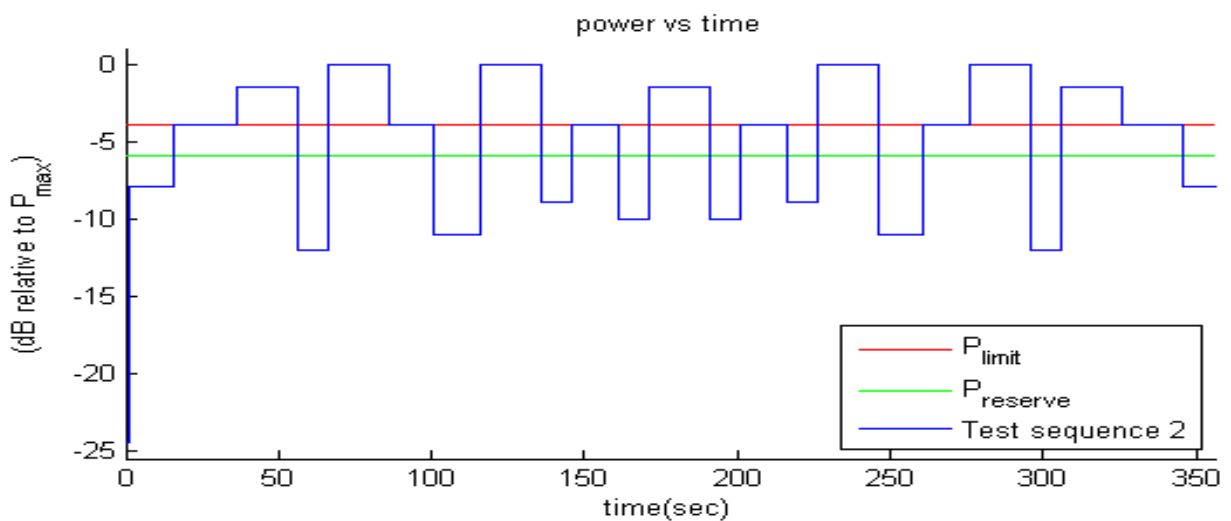
Figure 1 Test sequence 1 waveform

3. Test Sequence 2 Waveform:

Based on the parameters in A-1, the Test Sequence 2 is generated as described in Table A-1, which contains two 170 second-long sequences (yellow and green highlighted rows) that are mirrored around the center row of 20s, resulting in a total duration of 360 seconds:

Time duration (seconds)	dB relative to P_{limit} or $P_{reserve}$
15	$P_{reserve} - 2$
20	P_{limit}
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
10	$P_{reserve} - 6$
20	P_{max}
15	P_{limit}
15	$P_{reserve} - 5$
20	P_{max}
10	$P_{reserve} - 3$
15	P_{limit}
10	$P_{reserve} - 4$
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
10	$P_{reserve} - 4$
15	P_{limit}
10	$P_{reserve} - 3$
20	P_{max}
15	$P_{reserve} - 5$
15	P_{limit}
20	P_{max}
10	$P_{reserve} - 6$
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
20	P_{limit}
15	$P_{reserve} - 2$

Table -1 Test Sequence 2



The Test Sequence 2 waveform is shown in Figure A-2

Appendix B: Test Procedures for sub6 NR + LTE Radio

Appendix B provides the test procedures for validating Qualcomm Smart Transmit feature for LTE + Sub6 NR non-standalone (NSA) mode transmission scenario, where sub-6GHz LTE link acts as an anchor.

B.1 Time-varying Tx power test for sub6 NR in NSA mode

Follows Section 5.2.1 to select test configurations for time-varying test. This test is performed with two pre-defined test sequences (described in Section 5.1) applied to Sub6 NR (with LTE on all-down bits or low power for the entire test after establishing the LTE+Sub6 NR call with the callbox). Follow the test procedures described in Section 5.3.1 to demonstrate the effectiveness of power limiting enforcement and that the time averaged Tx power of Sub6 NR when converted into 1gSAR values does not exceed the regulatory limit at all times (see Eq. (1a) and (1b)). Sub6 NR response to test sequence1 and test sequence2 will be similar to other technologies (say, LTE), and are shown in Sections 8.3.7 and 8.3.8.

B.2 Switch in SAR exposure between LTE vs. Sub6 NR during transmission

This test is to demonstrate that Smart Transmit feature accurately accounts for switching in exposures among SAR for LTE radio only, SAR from both LTE radio and sub6 NR, and SAR from sub6 NR only scenarios, and ensures total time-averaged RF exposure compliance with FCC limit.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE and sub6 NR in selected band. Test condition to measure conducted P_{limit} is:

- Establish device in call with the callbox for LTE in desired band. Measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enabled and Reserve_power_margin set to 0 dB, callbox set to request maximum power.

- Repeat above step to measure conducted Tx power corresponding to Sub6 NR P_{limit}. If testing LTE+Sub6 NR in non-standalone mode, then establish LTE+Sub6 NR call with callbox and request all down bits for radio1 LTE. In this scenario, with callbox requesting maximum power from Sub6 NR, measured conducted Tx power corresponds to radio2 P_{limit} (as radio1 LTE is at all-down bits)

2. Set Reserve_power_margin to actual (intended) value with EUT setup for LTE + Sub6 NR call. First, establish LTE connection in all-up bits with the callbox, and then Sub6 NR connection is added with callbox requesting UE to transmit at maximum power in Sub6 NR. As soon as the Sub6 NR connection is established, request all-down bits on LTE link (otherwise, Sub6 NR will not have sufficient RF exposure margin to sustain the call with LTE in all-up bits). Continue LTE (all-down bits)+Sub6 NR transmission for more than one time-window duration to test predominantly Sub6 NR SAR exposure scenario (as SAR exposure is negligible from all-down bits in LTE). After at least one time-window, request LTE to go all-up bits to test LTE SAR and Sub6 NR SAR exposure scenario. After at least one more time-window, drop (or request all-down bits) Sub6 NR transmission to test predominantly LTE SAR exposure scenario. Continue the test for at least one more time-window. Record the conducted Tx powers for both LTE and Sub6 NR for the entire duration of this test.

3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and Sub6 NR links. Similar to technology/band switch test in Section 5.3.3, convert the conducted Tx power for both these radios into 1gSAR value (see Eq. (6a) and (6b)) using corresponding technology/band P_{limit} measured in Step 1, and then perform 100s running average to determine time-averaged 1gSAR versus time as illustrated in Figure 3-1. Note that here it is assumed both radios have Tx frequencies < 3GHz, otherwise, 60s running average should be performed for radios having Tx frequency between 3GHz and 6GHz.

4. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 2.

5. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 3, (b) computed time-averaged 1gSAR versus time determined in Step 3, and (c) corresponding regulatory 1gSAR_{limit} of 1.6W/kg.

The validation criteria is, at all times, the time-averaged 1gSAR versus time shall not exceed the regulatory 1gSAR_{limit} of 1.6W/kg.

Appendix C: Verification plot

Verification Data (30 GHz)

Test Laboratory: HCT CO., LTD
 EUT Type: Tablet
 Test Date: 07/14/2020
 Plot No.: 1

Device Under Test Properties

Name, Manufacturer	Dimensions [mm]	DUT Type
Verification source	100.0 x 100.0 x 100.0	Verification source

Exposure Conditions

Phantom Position, Test Distance Section [mm]	Band	Group, UID	Frequency [MHz], Channel Number
5G FRONT, 5.55	Validation band	CW, 0--	30000.0, 30000

Hardware Setup

Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave - xxxx	Air -	EUmmWV3 - SN9382, 2019-07-25	DAE4 Sn1225, 2019-11-18

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	5.55

Measurement Results

Scan Type	5G Scan
Date	2020-06-29, 22:33
Avg. Area [cm ²]	4.00
pS _{tot} avg [W/m ²]	21.2
pS _n avg [W/m ²]	21.1
E _{peak} [V/m]	104
Power Drift [dB]	0.11

